# A PROGRAM TO EVALUATE

# UNIFORM RANDOM NUMBER GENERATORS

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## ABSTRACT

This thesis presents a program to evaluate uniform pseudo-random number generators. It presents various methods of generation and the tests available to test the adequacy of the methods. The program is employed to test a number of frequently used generators and the results are reported. The strengths and weaknesses of the programmed tests are also discussed.

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## CHAPTER 1

### RANDOM NUMBER GENERATORS

### A. Introduction

There have been many words written and spoken on the relative merits and shortcomings of various types of uniform random number generators. As soon as a new algorithm or procedure is presented as being totally random and unbiased a critic of the new method discovers an area where the performance of the procedure is less than ideal. This type of banter has been going on for years and with the emergence of the digital computer and the availability of a high-speed means of generating these numbers the arguments are becoming more and more frequently found than ever in the journals of computer and statistical methodology. One point, however, is not argued; that is the statistical importance of random number generators in a wide variety of applications.

Random numbers are useful in many areas. For example:

a. Simulation - when a computer is used to simulate natural phenomena, random numbers are required to make things realistic. The term simulation is rather broad and covers studies from nuclear physics and space technology to queuing theory (for example, people entering a bank or cafeteria at random intervals expecting services) and computer software simulation (analysis of various types of software, hardware, peripherals and job streams to optimize throughput).

- b. Sampling in many statistical analyses it is often impractical to examine all possible cases due to the large number of possibilities.
  A well chosen random sample, will, however, allow the statistician to draw meaningful conclusions from the data and gain insight into the problem from a substantially smaller subset of observations.
- c. Numerical analysis many techniques for solving complicated numerical problems have been devised using random numbers.
- d. Computer programming random values make a good source of data for testing the effectiveness of computer algorithms.
- e. Decision making random numbers are becoming increasingly more important in association with corporate and industrial decisions. Techniques such as decision theory and risk analysis employ random numbers in a simulation type application to aid managers in evaluating various alternatives.
- f. Recreation rolling dice, shuffling cards, playing roulette are all every day occurrences which involve random number theory. This commonplace use of random numbers has had the name "Monte Carlo Method" devised as the general term used to describe an algorithm that employs random numbers.

Although we have been and will probably continue to talk about random numbers, there really is no such entity as a random number. We cannot, for example, say 21 is a random number or 21 is not a random number. What we are actually saying is that we really are speaking about a sequence of independent random numbers with a previously

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specified distribution and that each number observed by us was obtained by chance, having nothing to do with other numbers in the sequence.

Uniformly distributed variables in the range zero to one (denoted (0,1)) play an important role in the generation of random variables drawn from other probability distributions such as the exponential, normal, Poisson and binomial distributions. In fact, random variables from these distributions are often derived by transforming one or more uniform (0, 1) random variables. For example,  $-\ln(r)$  where r is a random variable from a uniform (0, 1) yields an exponentially distributed random variable with mean 1. For this reason, we will concern ourselves primarily with the uniform distribution and the distributions referred to should be understood to be uniform unless some other distribution is explicitly stated.

A uniform distribution is one in which each possible number is equally probable. In other words each of the ten digits 0 through 9 will occur about 1/10 of the time in a (uniform) sequence of random digits. Each pair of two successive digits (00 through 99) should occur about 1/100 of the time and so on. Yet if we take a truly random sequence of 1000 digits, it will not always have exactly 100 zeros, 100 ones, etc. In fact, the probability of this actually occurring is quite small; however, a sequence of such sequences will have this character on the average.

Another quality of a random number generator besides the frequency of the appearance of the digits, is the actual sequence of the digits.

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A sequence such as

or

might have each digit appear with the same frequency but indeed there is a suspicious ordering to the digits which would cast doubt on the validity of the generator.

There are several ways to formulate a good abstract definition of a random sequence but perhaps we should begin with an intuitive approach to the concept.

One of the first published accounts of random digits appeared in 1927 as a table of over 40,000 random digits taken at random from census reports. This table was compiled by L. H. C. Tippett (17). Since then a number of machines were built for mechanically generating random numbers. M. G. Kendall and B. Babington-Smith (7, 8) describe such a machine in their papers in the Journal of the Royal Statistical Society. The machine essentially consisted of a spinning disk divided into ten equal sections, each having a digit from 0 to 9 on it. The disk was caused to spin at a relatively high speed in a dark room. The operator would at unequal intervals press a button to flash a light on for an instant which would illuminate the spinning disk, making it appear motionless and noticing the digit at which a previously mounted pointer was indicating. Statistical analyses of the sequences generated by the above method proved it to be a reasonable means of random number generation.

Shortly after computers were introduced people began to search for efficient ways to obtain random numbers in computer programs. One obvious way is to read in tables of already known random sequences. This method, however, is of limited utility because of memory available, input time requirement, the table may be too short for the application and it certainly seems like it would be a nuisance to prepare and maintain the table. Obviously, the computer should be programmed to generate its own random number sequences.

## B. Random Numbers by Computer

The idea of using the computer and its inherent high speed for generating random numbers was suggested in the 1940's by John von Neumann. His method was called the "middle square" method and consisted of using the previously generated random number, squaring it and extracting the middle digits as the new random number. So, for instance, if we were generating 10-digit numbers and the previous value was 5, 772, 156, 649 the new random number would be 7923805949 (the middle ten digits of 33317792380594909291).

One obvious objection to this technique is how can a sequence generated in such a way be random since each number is completely determined by its predecessor. The answer, of course, is that the sequence is not random, but it appears to be. For this reason such deterministically

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generated sequences are called pseudo-random or quasi-random sequences. Although they are derived from a fully specified formula by a digital computer, their statistical properties coincide with the statistical properties of numbers generated by an "idealized chance device" that selects numbers from the unit interval independently and with all numbers equally likely. Provided that these pseudo-random numbers can pass the set of statistical tests (frequency tests, autocorrelation tests, lagged product tests, runs tests, gap test and others all of which will be fully detailed in this paper) implied by an idealized chance device, then these pseudo-random numbers can be treated as "true" random numbers even though they are not.

Naylor (15) proposes several criteria that should be satisfied by an ideal pseudo-random number generator. An ideal pseudo-random number generator should yield sequences of numbers that are 1) uniformly distributed, 2) statistically independent, 3) reproducible and 4) nonrepeating for any desired length. Furthermore, such a generator should also be capable of 5) generating random numbers at high rates of speed, yet of 6) requiring a minimum amount of computer memory capacity. He also states that congruential methods of random number generation come closer to satisfying all of these criteria than any other known method. <u>Congruential Methods</u>

The congruential methods for generating pseudo-random numbers are . based on the mathematical concept of congruence which basically states

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that two numbers a and b are congruent modulo m if their difference is an integral multiple of m. The congruence relation is expressed by the notation  $a \equiv b \pmod{m}$  and is read "a is congruent to b modulo m." In other words a-b is exactly divisible by m which also implies that a/m and b/m have the same remainders.

The following recursive formula is basic to all congruential methods.

$$X_{n+1} = (aX_n + c) \mod m \quad n > 0 \quad (I-1)$$

where  $X_0$ , a, c, and m are all non-negative integers. Expanding (I-1) for i = 0, 1, 2... we obtain

$$X_{1} = (aX_{0} + c) \mod m$$
  

$$X_{2} = (a(aX_{0} + c) \mod m)$$
  

$$= a^{2}X_{0} + (a + 1) c \mod m$$
  

$$X_{3} = a^{3}X_{0} + (a^{2} + a + 1) c \mod m$$
  

$$= a^{3}X_{0} + \frac{(a^{3} - 1)}{(a - 1)} c \mod m$$
  

$$X_{i} = a^{i}X_{0} + \frac{(a^{i} - 1)}{(a - 1)} c \mod m$$
 (I-2)

Given an initial starting value  $X_0$ , a constant multiplier a, and an additive constant c, then (I-2) yields a congruence relationship (modulo m) for values of i, i=0, 1, 2...

This sequence is called a linear congruence sequence. For example, the sequence obtained when  $X_0 = a=c=7$ , m=10, is 7, 6, 9, 0, 7, 6, 9, 0, ... As this example shows, the sequence is not always "random" for all choices of the initial parameters; in fact the choice of these values is extremely

critical in producing useful random sequences.

The above example illustrates another characteristic of congruential sequences: they always get into a loop or begin repeating themselves. This repeating cycle is called the period; the sequence above having a period of 4. Obviously a useful sequence will have a relatively long period.

Two types of congruential methods have been derived from Equation (I-2). When c = 0 the term multiplicative congruential generator is often used and when  $c \neq 0$  often the term mixed congruential method is employed. The case c = 0 generally proceeds a little faster than when  $c \neq 0$ . However the restriction c = 0 cuts down the length of the period of the sequence although careful selection of the other parameters still allows for a reasonably long period.

Far and away, the most widely used method of generating random numbers by computer employs in one variation or another a congruential method. In almost all of these cases the method used is a multiplicative congruential method or a mixed congruential method. These two methods and two variations of them are discussed below.

### The Multiplicative Method

The multiplicative congruential method computes a sequence  $\{X_i\}$  of non-negative integers less than m by means of the congruence relation

$$X_{i+1} = aX_i \mod m$$
 (I-3).

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This method is a special case of the congruence relation (I-1) where c = 0. This method has been found to behave quite well from a statistical point of view. Given a prudent choice of the multiplier a and starting value (or seed)  $X_0$ , it is possible to generate sequences of numbers that are uncorrelated and uniformly distributed. Additionally, careful choice of the two above-mentioned parameters guarantees a maximum period for sequences generated by this method. Knuth (9) states the following theorem concerning multiplicative congruential generators and cites the proof by R. D. Carmichael, <u>Bulletin of the</u> American Math. Society, Vol, 16, (1910), pp 232-38.

## Theorem

The maximum period possible when c = 0 (a multiplicative congruential method) is achieved if

1) X is relatively prime to m

2) a is a primative element modulo m.

To clarify the above theorem it is also necessary to note that when a is relatively prime to m, the smallest integer  $\lambda$  for which  $a^{\lambda} \equiv 1 \pmod{m}$ is called "the order of a, modulo m". Any value of a which gives the <u>maximum</u> possible order modulo m is called a "primative element, modulo m."

If we let  $\lambda(m)$  denote the order of a primative element, i.e., the maximum possible order, modulo m, we can show (Knuth) that  $\lambda(p^e)$ , where p is a prime number and e a positive integer, p > 2, is a divisor

of  $p^{e-1}(p-1)$ . The precise value of  $\lambda(m)$  for all cases can then be given as

$$\begin{array}{l} \lambda(2) = 1 \\ \lambda(4) = 2 \\ \lambda(2^{e}) = 2^{e-2}, \ e \ge 3 \\ \lambda(p^{e}) = p^{e-1}(p-1), \ p \ge 2. \end{array}$$

This theory simplifies somewhat when we note that as applicable to computer generated random numbers p represents 2 or 10 depending on whether the generator is to be run on a binary or decimal computer and e represents the number of bits per word available for computation. For the IBM 360 then p = 2, e = 31.

Knuth then presents another theorem as follows:

# Theorem

a is a primative element modulo p<sup>e</sup> if and only if

Once again this theory simplifies in the common case where  $m = 2^e$ ,  $e \ge 4$ and our sole requirement is that a = 3 or 5 (modulo 8).

## The Mixed Method

The mixed congruential method computes a sequence of  $\{X_i\}$  of nonnegative integers less than m by means of the congruence relation given by

$$X_{i+1} = aX_i + c \pmod{m}.$$

This method differs from the multiplicative procedure in that c is not assumed to be zero. The advantage of this method is that it is possible to obtain sequences with a period that covers the full set of m different numbers (the multiplicative method has a maximum period of m-1). From a computational and speed standpoint this method requires an extra addition operation compared to the multiplicative method.

The theorem concerning the maximum period for a linear congruential sequence is as follows:

### Theorem

The linear congruential sequence has a period of length m if and only if

- . i) c is relatively prime to m
  - ii)  $a \equiv 1 \pmod{p}$ , p is a prime factor of m
- iii)  $a \equiv 1 \pmod{4}$  if 4 is a factor of m.

The practical considerations of this condition, when dealing with binary computers, is relatively straightforward. To achieve a full period  $h = m = 2^e$  the parameter c must be odd and a must satisfy the congruence relationship

 $a \equiv 1 \pmod{4}$ 

which can always be achieved by setting  $a = 2^k + 1$  for  $k \ge 2$ . Any positive integer can be selected for the starting value  $X_0$ . However the above-mentioned conditions are not in themselves sufficient for assuming that sequences generated by the mixed congruential method will be statistically satisfactory. Naylor states that only by empirical testing can we have confidence in the statistical properties of sequences that are produced.

## The Combination Methods

Within a few years after their discovery, congruential methods came under attack in the literature on the grounds that the sequences generated were not statistically satisfactory especially with respect to autocorrelation (a measure of the tendency of numbers in the sequence to show a linear functional relationship to other numbers in the sequence a given but constant distance away). As a result of these findings, several new versions of congruential methods were suggested in the literature.

MacLauren and Marsaglia (11) suggested two combination methods. The first method, to be used on computers with buffered input, reads in a tape of p previously stored random numbers. Then, a congruential generator computes an index that determines which random number is selected from the inputted sequence. This process is continued until all the inputted numbers are exhausted at which time a new tape is read and the process continues. The second method suggested by these two men uses two random number generators. To begin, a table of 128 locations in core was filled with numbers generated by the first generator. To output random numbers the second generator computed an index to determine the location in the table of the random number to be used. The location in the table was refilled with a new number generated from the first congruential generator. MacLauren and Marsaglia recognize that the time required using this method is about twice the time required in a non-combination method but they strongly feel the time penalty is worth suffering to obtain a sequence of numbers with better statistical properties. In fact an article written three years later by Marsaglia and Bray (14) presents a combination method that involves three congruential generators. They state "short and fast programs will result even if three generators are mixed. One to fill, say 128 storage locations, one to choose a location from the 128 and a third thrown in just to appease the gods of chance. Why be half (or two-thirds safe)? "

Another method of generating pseudo-random numbers based on the combination of two congruential generators has been proposed by Westlake (18). It retains two of the desirable features of congruential generators, namely, the long cycle and the ease of implementation with a digital computer. Unlike the combination method of MacLauren and Marsaglia, Westlake's method does not require the retention in memory of a table of generated numbers. Westlake, instead, uses the two generators and does bit-wise addition followed by division. To further insure randomness, Westlake also adopted the procedure of modifying

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one random number by permuting its bits in a random manner determined by the other random number. Like the generators of MacLauren and Marsaglia, this procedure yielded completely satisfactory results on a fairly stringent series of statistical tests.

The combination methods are so prevalent as to be too numerous to describe. More recently, however, the enthusiasm has been dampened somewhat by the paper by Coveyou and MacPherson (1). They conclude, through Fourier analysis, that any multiplicative generator is statistically satisfactory if its multiplier meets certain requirements. On the other hand Marsaglia (13) still maintains that every multiplicative generator has a defect which makes it unsuitable for certain Monte Carlo problems namely - points produced in the n-cube fall in a relatively small number of parallel hyper-planes.

## Other Methods

Of course, linear congruential methods of pseudo-random number generating are not the only methods ever suggested for computer use. There are a number of other methods which should be briefly discussed.

One of the common fallacies encountered in connection with random number generation is that a good generator can be modified slightly to yield an even better generator. Actually this is not so and in fact the new generator is oftentimes less random than the original one. Knuth expresses this idea as a moral to an episode where he thought he was creating a fantastically good random number generator using

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a rather complicated and peculiar algorithm, without actually examining the theory behind the algorithm. The algorithm when implemented proved deficient in many areas and led Knuth to state "random numbers should not be generated with a method chosen at random."

Two additional methods of generating random numbers are quadratic congruential methods of the form

$$X_{n+1} = (dX_n^2 + aX_n + c) \mod m$$
 (I-4)

and

$$X_{n+1} = X_n(X_n + 1) \mod 2^e, X_0 \mod 4 = 2.$$
 (I-5)

In the case of (I-4) the sequence has a period of length m provided parameters a, c and d are properly chosen. Case (I-5) involves less computation time than (I-4), in fact just slightly more time than the linear congruential form of (I-1).

One other nonlinear congruential method of generating random numbers involves using the Fibonacci sequence,  $X_{n+1} = X_n + X_{n-1}$ . This sequence, which in itself is important in describing many natural phenomena can be modified by division modulo m to produce a random sequence of a relatively long period. However, recent studies of such sequences have proved them not to be satisfactorily random. A slight modification to the Fibonacci sequence to the form

$$X_{n+1} = (X_n + X_{n-k}) \mod m$$

when k is comparatively large has been shown to produce acceptable sequences of random numbers (k = 16).

There are therefore different and varied methods of generating random numbers by computer. Without knowledge of the particular application however it would be indeed difficult to recommend one over any other. Chapter 2 deals with various statistical tests to aid in selecting a satisfactory generator.

## CHAPTER 2

# STATISTICAL TESTS FOR EVALUATING RANDOM NUMBER GENERATORS

The statistical properties of pseudo-random numbers generated by methods such as those described in Chapter 1 should of course coincide with the statistical properties of numbers generated by an idealized chance device that selects numbers from the unit interval (0, 1) independently and with all numbers equally likely. Obviously, as we have previously mentioned, the numbers generated by computer are not random because they are completely determined by a number of initial parameters and have their precision limited to the accuracy of the computer. However, we will agree that as long as our pseudo-random numbers can pass a rigid set of statistical tests that the idealized generator would theoretically also pass, the pseudo-random numbers will be treated as "truly" random numbers.

Because random number generators are frequently used in the simulation of nondeterministic or stochastic systems the importance of the statistical agreement described above becomes evident. For example, if the probability of the occurrence of a physical event at a given point in time is . 60, then if the generated random number assigned to that event at that point in time is less than or equal to . 60 the event is assumed to have occurred. A generated random number between . 60 and 1. would imply the event at this point in time did not occur. Generally, in this manner the entire course of events of a given case are run or simulated and the final outcome along with relevant intermediate results are reported. Obviously a poor or biased random number generator would tend to cast suspicion as to the accuracy of the simulation. A number of statistical tests are available to examine pseudo-random sequences and which allow the analyst or statistician to make statements concerning the apparent randomness or lack of it in a given sequence. There is literally no end to the number of tests that can and have been conceived and, in fact, for specific applications oftentimes a specific test need be developed to protect against biased introduced by the peculiarities of the application itself. In general there are a number of more common tests and these are described below.

#### A. Moments

An obvious and desirable characteristic of a pseudo-random number generator on the unit interval is agreement between the observed moments and the known theoretical ones. The first moment, or average, is calculated as

$$\overline{\mathbf{X}} = \frac{1}{N} \sum_{i=1}^{N} \mathbf{X}_{i}.$$
 (II-1)

The expected value for this quantity would be 1/2. The second moment, denoted  $\overline{X^2}$ , is expressed as

$$\overline{x^{2}} = \frac{1}{N} \sum_{i=1}^{N} x_{i}^{2}$$
(II-2)

and its theoretical value is 1/3. The third moment, or  $\overline{X}^3$  is expressed as

$$\overline{x}^{3} = \frac{1}{N} \sum_{i=1}^{N} x_{i}^{3}$$
 (II-3)

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and it has a theoretical value of 1/4. Another quantity directly related to moments, and in the case of a 0 mean distribution identical to the second moment is the variance, denoted  $S^2$ , and calculated as

$$S^{2} = \overline{X^{2}} - \overline{X}^{2} = \frac{1}{N} \sum_{i=1}^{N} (X_{i} - \overline{X})^{2}$$
 (II-4)

The variance of a uniform distribution on the unit interval (0, 1) is 1/12.

B. Chi-Square ( $\chi^2$ ) Tests

The  $\chi^2$  test is perhaps the best known of all statistical tests and it is a basic method which is often used in connection with many other tests. To apply this test we divide the range (0 to 1) of the N samples into r classes and determine the number of samples,  $V_i$ , which fall into each class. From the assumed theoretical distribution we compute  $p_i$ , the probability of being in the ith class. Then Np<sub>i</sub> is the expected number in the ith class and a statistic  $\chi^2$  is defined as

$$\chi^{2} = \sum_{i=1}^{r} \frac{(V_{i} - Np_{i})^{2}}{Np_{i}}$$

and represents a measure of dispersion between the data and the assumed distribution. A comparison can then be made with the computed value of  $\chi^2$  and a known value of  $\chi^2$  such that if the calculated value is larger than the known value from a table a very small probability can be attached to the conclusion that the observed observations were actually drawn from the assumed distribution. Also, if we have k-independent sets of N observations we can perform similar tests on the k calculated values of  $\chi^2$ . The selection of class width is somewhat arbitrary. Generally speaking class width should be chosen so that all Np<sub>i</sub> are at least 5 and probably should be nearer to at least 10. The lengths of the class intervals need not all be the same but except for the endpoints of some distributions where larger class widths are needed to satisfy the requirement of Np<sub>i</sub> > 5, there is not much to be gained by unequal interval sizes. Mann and Wald (10) suggest using k intervals where

$$k = 4 \sqrt[5]{2(n-1)^2/c^2}$$

and c is related to the size of the critical region (the probability associated with the critical region under the null hypothesis or significance level). Some values of c for different significance levels are shown below in Table II-1.

# TABLE II-1 Mann-Wald Values of c for Some Significance Levels

Significance Level	<u> </u>
.001	3.09
.01	2.327
. 025	1.960
.05	1.645
. 10	1.282
. 15	1.037
.20	. 842

Another consideration might lead to a different number of classes. For example, if many times in the simulation model using the pseudo-random number generator under scrutiny a choice is made between n equally likely alternatives it might be expeditious to choose k = n. As Gorenstein (4) points out, in the final analysis it is up to the user to design tests to suit the needs of his simulation. There can be no general method that will guarantee good results.

# C. The Kolmogorov-Smirnov Test

The  $\chi^2$  test applies to the situation where observations fall or are arbitrarily placed in a finite number of categories. It is commonplace however to consider random quantities which may assume infinitely many values, e.g., random variables on the (0, 1) interval, and for some reason be unwilling to set up arbitrary classes. By examining the cumulative distribution function we can eliminate the need of setting up arbitrary class sizes and use the Kolmogorov-Smirnov Test (K-S test).

The cumulative distribution function, denoted F(X), where

$$\mathbf{F}(\mathbf{X}) = \Pr \{\mathbf{x} \leq \mathbf{X}\}$$

indicates the probability that a random variable x is less than or equal to some given value X. In the case of a uniformly distributed variable on the unit interval (0, 1),  $\Pr\{x \le X\} = X$ . For example  $\Pr\{x \le 2/3\} = 2/3$ . If we made N independent observations or

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samplings of the random variable x, obtaining the values  $x_1, x_2, \dots, x_N$ we can form the empirical cumulative distribution function

$$F_N(X) = \frac{\text{number of } x_i \leq X}{N}$$

As N increases  $F_{N}(X)$  should be a better and better approximation of F(X).

The K-S test may be used when F(X) has no jumps. It measures the concordance between F(X) and F(X). A poor random number generator will yield an empirical distribution function which will not approximate F(X) very well.

To apply the K-S test to the unit interval (0, 1) where we have a sequence of N random observations we form the following two statistics:

$$K_{N}^{+} = \sqrt{N} \quad Max \quad (F_{N}(X) - F(X))$$
  
 $0 < x < 1$   
 $K_{N}^{-} = \sqrt{N} \quad Max \quad (F(X) - F_{N}(X)).$   
 $0 < x < 1$ 

Here  $K_N^{\dagger}$  measures the greatest amount of deviation when  $F_N$  is greater than F, and  $\bar{K_N}$  represents the maximum amount deviation when F is less than F.

As in the  $\chi^2$ -test, we may now look up critical values of  $K_N^+$ ,  $K_N^$ in a table to determine if they are significantly high or low and thus decide if our sampled distribution does, in fact, resemble the hypothesized distribution.

Although the Kolmogorov-Smirnov test is a more statistically accurate test than the  $\chi^2$ -test, there are a number of disadvantages associated with it. Some of the main disadvantages are 1) all N observations must be available during the test 2) the observations, although obtained in a random order, must be sorted in ascending order and 3) there are a considerably greater number of calculations involved in the K-S test as compared to the  $\chi^2$ -test.

#### Runs Tests

D. The expected random oscillatory nature of sequences of pseudo-random numbers can be tested by "runs tests". Two standard types of runs tests are runs up and down and runs above and below the mean.

Runs up and down - Let  $x_1, x_2, \dots, x_N$  be a sequence of N unequal numbers. Consider a sequence of N-1 signs,  $a_i$ , where  $a_i$  is the sign of  $x_{i+1}-x_i$ . A sequence of p consecutive plus signs not immediately followed or preceded by a plus sign is called a "run up of length p". An analogous sequence of minus signs is called a "run down of length p".

For example the sequence

1 5 19 15 13 12 18 2 4 9 11

gives ++ - - - + - + + +

which has a run up of 2 followed by a run down of 3, up of 1, down of 1, and

up of 3.

If we let

r = number of runs in the sequence
rp = number of runs of length p in the sequence
r + = number of runs of length p or more in sequence
p

then

$$E(r) = 1/3 (2N-1); Var(r) = (16N-29)/90, \qquad (II-7)$$

$$E(r_p) = 2N(p^2+3p+1)-2(p^3+3p^2-P-4) / (p+3)!$$
for  $p \le N - 2$ , (II-8)

$$E(r_p^+) = 2N(p+1) - 2(p^2+p-1) / (p+2)! \text{ for } p \le N-1$$
 (II-9)

and

$$\frac{\mathbf{r}-\mathbf{E}(\mathbf{r})}{\sqrt{\operatorname{Var}(\mathbf{r})}}$$
(II-10)

is asymptotically normally distributed as  $N \rightarrow \infty$  with mean 0 and variance 1. We, therefore, can easily test the hypothesis  $H_0: r=E(r)$  by calculating (II-10) and comparing it to the value in the appropriate table of the normal distribution. Likewise, the  $\chi^2$  goodness of fit test may be used to check whether a pseudo-random number generator is acceptable based on the distribution of length of runs. A common characteristic of nonrandom sequences of numbers is an excess of long runs.

Runs above and below mean - The expected number of runs above and below the mean is

$$E(r^{(m)}) = \frac{N}{2} + 1$$
 (II-11)

where  $r^{(m)}$  is the number of runs above and below the mean. These runs are counted by constructing a sequence of N signs with the plus or minus depending on whether X<sub>i</sub> is greater or less than the mean of the distribution (1/2 in our case). The expected total number of runs of length p is (N-p+3)2<sup>-k-1</sup>. A  $\chi^2$ -test may be used to check whether a given pseudo-random number generator is acceptable.

## E. Serial Tests

## 1) Pairs Test

For a locally random series no number shall tend to be followed by any other number. If we, therefore, construct a table with the rows representing a frequency distribution of the first number of a pair of uniform random values and the columns representing a frequency distribution of the second number of the pair we would expect the frequencies to be approximately equal in all cells after N pairs had been examined. To test this hypothesis we could apply the  $\chi^2$  test to these cells of the table with the theoretical or expected number of observations in each cell equal to N/number of cells. Clearly it would be possible to extend this test to triples, quadruples, etc.; however, the size of the table increases rapidly and to insure an expected theoretical value of at least five or ten the total number of observations needed begins to get quite large. Also, the calculations required to compute  $\chi^2$  begin to use substantial computer time.

It would be appropriate to note here that it would be a mistake to perform the serial test on the pairs  $(x_1, x_2)$ ,  $(x_2, x_3)$  ...  $(x_{2N-1}, x_{2N})$ 

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because the chi-square test requires independence of the observations. Rather, for this particular test we should use the pairs  $(x_1, x_2)$ ,  $(x_3, x_4) \dots (x_{2N-1}, x_{2N})$  which yields approximately half as many observations as the incorrect former method.

## 2) Autocorrelation

The autocorrelation function is a measure which is widely used in the study of stochastic processes. If we let  $x_i$ , i = 1, 2, ...be a sequence from the unit interval (0, 1), then we may define the autocorrelation function of a sample of length N from this sequence as

$$R(t) = 1/12 \sum_{i=1}^{N-t} (x_i - 1/2) (x_{i+t} - 1/2)$$
(II-12)

where t is commonly referred to as the length of the lag and R(t) as the autocorrelation at lag t.

The correlation coefficient always lies between -1 and +1. When it is zero or near zero, it indicates that the sequences  $\{x_i\}$  and  $\{x_{i+t}\}$ are (statistically speaking) independent of each other. When the correlation coefficient is near  $\frac{1}{2}$  1 (it indicates a high degree of linear dependence between the two sequences. A value of  $\frac{1}{2}$  1 would indicate total dependence and, in fact,

 $x_{i+t} = ax_i + b$ 

for some constants and and b.

A satisfactory random sequence would have autocorrelations near zero for all lags tested.

# F. Gap Test

All of the preceding tests have been conceived for randomness of numbers where each number consisted of some fixed or finite number of digits. The gap test for digits is concerned with the randomness of the digits in a sequence of numbers. For any given digit d, we can examine the lengths of the gaps of "non-d" digits between any two "d-digits". In other words, a gap of length k occurs when k "non-d" digits occur between two "d-digits". Two consecutive d's produce a zero gap.

The theoretical probability of obtaining a gap of length k is

Pr {gap = k} =  $(.9)^{k}$  (.1) (II-13) For a given sequence of digits, tallies are made of the number of gaps occurring for each length. A chi-square goodness of fit test can be used to compare expected and theoretical number of gaps.

A second type of gap test does not examine digits but examines the actual random number. In this case, a gap is the number of consecutive observations in the sequence that do not fall between a specified a and b. Generally, a tally is kept as to gaps of lengths 0, 1, 2... t-1, and the number of gaps of length t or greater.

In the case of examining pseudo-random numbers between zero and one, we would have the following relationship

 $0 \leq a \leq b \leq 1$ 

and the following probabilities associated with the gap lengths

Pr {gap = 0} = b-a  
Pr {gap = 1} = (b-a) (1-(b-a))  
Pr {gap = 2} = (b-a) (1-(b-a))<sup>2</sup>  
.  
Pr {gap = t-1} = (b-a) (1-(b-a))<sup>t-1</sup>  
Pr {gap 
$$\ge$$
 t} = (1-(b-a))<sup>t</sup>

Chi-square tests can also be applied here as in the digit gap test.

# G. Maximum Test

For a set of N independent uniform random numbers,  $x_1, x_2, \dots, x_N$ , in the unit interval (0, 1), we can define a random variable  $W = Max (x_1, x_2, \dots, x_N)$  and the distribution of W is given by  $F (W) = max (x_1, x_2, \dots, x_N) \stackrel{N}{\dots}$  (II-14) Since Pr {W < a} = F(a) = a<sup>N</sup> for 0 < a < 1, F (w) as defined in (II-14) is distributed over the unit interval with a cumulative distribution function  $F(W \le w) = W^N$ . By sampling several sets of N independent random numbers we can use the  $\chi^2$ -test on the distribution of W.

### H. Minimum Test

This test is the same as the maximum test of N except that the minimum of  $(x_1, x_2, \dots, x_N)$  are taken and the corresponding distribution function used.

At this point it might be wise to close by answering the question as to why are so many tests necessary. It seems like more time is spent testing the numbers than in using them. This is probably not true but the importance of knowing the shortcomings of a particular random number generator cannot be understated. This is because the simulation, risk analysis or other models using the particular random number generator are highly dependent on the accuracy and unbiasedness of the generator for their value as viable tools. If confidence cannot be established in the random number generator of these models, there is little likelihood of people believing in the models that employ these generators. With confidence established in the random number generator the question of confidence in the actual model is at least reduced to the assumptions and relationships developed therein.

## CHAPTER 3

# A PROGRAM TO EVALUATE UNIFORM RANDOM NUMBER GENERATORS

### A. Introduction

The computer program described in this section performs eight standard statistical tests on a vector of random numbers. The vector can be input to the program or the subroutine which generates the vector can be linked to the main program and the random numbers generated at execution time. The eight tests available are:

- 1. Gap test
- 2. Runs test
- 3. Pairs test
- 4. Chi-square test
- 5. Moments
- 6. Runs above/below mean
- 7. Autocorrelations
- 8. Kolmogorov-Smirnov test.

The program is written in FORTRAN IV and was compiled using the IBM FORTRAN G compiler on a System 360 Model 65. The program runs in approximately 120 K bytes of core and uses a temporary disk file to store the vector of random values. The maximum length of this vector is essentially unlimited as the program reads the random numbers into core from the temporary file in blocks of 10,000.

## B. System Control Cards

The user documentation contained herein assumes that the program is available in a load module form, i.e. it has been compiled and link edited. To execute the program, therefore, the function RAN need only be compiled and linked to the main program. Although RAN will be called only if the user specifies that random numbers will be generated during execution, its module must always exist, therefore the load module contains a dummy function RAN. This function is as follows:

FUNCTION RAN (NX)

RAN = 0.0RETURN

#### END

If the user is to read his random vector from an already created file the above dummy function will allow the load module to execute. If the user wishes to generate his vector of random values during execution he must compile his random number generator as a function named RAN (NSEED) and link edit this function into the load module in place of the existent dummy function. The mechanics of this procedure will of course vary from computer to computer. For an IBM/360 computer with the program load module located in an accessible library the following sequence of instructions will suffice. FORTGCLG is a catalogued procedure to execute a FORTRAN compile, link edit and go. It is comprised of three steps - FORT, LKED, and GO. TABLE III. 1 shows this procedure.

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### TABLE III. 1

# FORTGCLG - A Procedure to Execute FORTRAN Compile, Link Edit and Go

```
*** PROCEDURE FORTGCLG ***
                                                      *** PROCEDURE FORTGCLG ***
//FURTGCLG PROC FORMS='A,,0001',CPRM=SOURCE,LPRM=LIST,
     LIBR= UTCC.DUMMYLIB
//
         FORTRAN G COMPILE LINK EDIT AND GO
                                                ***
//****
//FORT
          EXEC PGM=IEYFORT, REGION=104K, TIME=10, PARM=*&CPRM*
//SYSPRINT DC SYSUUT=(&FORMS),DCB=(LRECL=120,BLKSIZE=3120,RECFM=FBSA),
     SPACE=(3120,(40,40))
//
//SYSLIN DD DSN=&&LOADSET, SPACE=(3120,(12,12)),DCB=BLKSIZE=3120,
    UNIT=SYSCA, DISP=(MOD, PASS, DELETE)
11
//SYSIN
          DD DSN=&&SOURCE, DISP=(OLD, DELETE, DELETE)
          EXEC PGM=IEWLF880, REGION=114K, CCND=(4, LT, FORT),
//LKED
11
          TIME=2, PARM=*XREF, LIST, LET, &LPRM, SIZE=(114K, 24K)*
//SYSPRINT DC SYSOUT=(&FORMS),DCB=BLKSIZE=605,SPACE=(605,(17,34))
//SYSLIN
          DD DSN=&&LCADSET, DISP=(OLD, DELETE, DELETE)
                DDNAME=SYSIN
            30
//
//SYSLMOD
           DD UNIT=SYSDA, DSN=&&GODATA(RUN), DISP=(, PASS, DELETE),
    SPACE=(TRK, (19, 10, 1))
11
//SYSLIB
           DC
               DSNAME=SYS1.FORTLIB, DISP=SHR
           DD DSN=&LIBR.DISP=SHR
11
           DSNAME=TEHO.LOADLIB, DISP=SHR
11
       DD
11
           DD DSN=SYS1.GULFMOD, DISP=SHR
//SYSUT1
          DD UNIT=SYSDA, SPACE=(TRK.(19,10))
//GD EXEC PGM=*.LKED.SYSLMOD.COND=((4,LT,FORT),(4.LT,LKED))
//SYSUDUMP DD SYSOUT=(&FORMS), SPACE=(TRK, (1,19))
//FT05F001 DC
               DDNAME=SYSIN
//FT06F001 DD SYSOUT=(&FORMS), SPACE=(TRK,(1,19)),
    DCB=(RECFM=VBA, LRECL=137, BLKSIZE=1100)
11
//FT07F001 DD SYSOUT=B, SPACE=(TRK, (1, 19)),
    DCB=(RECFM=FB,LRECL=80,BLKSIZE=800)
11
```
7

// EXEC FORTGCLG, REGION. GO=120K, LIBR='libr'
//FORT. SYSIN DD \*

FUNCTION RAN (NSEED)

FORTRAN Source

code for function RAN

RETURN

END

/\*

//LKED.SYSIN DD \*

INCLUDE SYSLIB (progname)

ENTRY MAIN

/\*

//GO.FT02F001 DD UNIT=SYSDA, SPACE=(TRK, (50, 10)), DISP=NEW,

// DCB=(RECFM=FB, LRECL=160, BLKSIZE=3200)

//GO.SYSIN DD \*

Program control

cards

/\*

where in the above deck listing:

libr denotes the library where the program load module

can be found,

progname denotes the name of the program.

In the Gulf Houston Datacenter, libr would be MSDC.LOADLIB and progname

would be MSHØ0074.

To run the Uniform Random Number Evaluation Program where the vector of random numbers is already on a file the following sequence of cards would be used. Once again we assume the program resides on an accessible library.

cc1 6

// EXEC PGM=progname, REGION=120K
//STEPLIB DD DSN=libr, DISP=SHR
//FTnnF001 DD UNIT=SYSDA, DSN=filename, DISP=OLD
//FT06F001 DD SYSOUT=A
//FT05F001 DD \*

Program control

cards

/\*

where in the above deck listing

progname denotes the name of the program

libr denotes the library where the program load module can be found

nn denotes the unit number of the file where

the vector of random numbers is located

filename denotes the name given to this file

### C. Program Control Cards

The program will evaluate, sequentially, an unlimited number of pseudo-random numbers. Each vector to be analyzed requires a single header card and then, depending on which tests are to be performed and whether or not the pseudo-random numbers have already been generated, a variable number of additional control cards.

# 1. Header Card

This card specifies the length of the vector to be analyzed, provides a seed if the pseudo-random numbers are to be generated during execution or the file number where the previously generated vector resides, specifies which tests are to be executed, and provides the user the option to print the vector of pseudo-random numbers. The format for the header card is as follows:

Card Column	Label	Description
1-10 (right justified)	NT	Number of random values in the vector
		if it is located on an already existing
		file or the number of values to be
		generated during execution using the
		supplied function RAN.
11-20	NSEED	Initial seed for random number
		generator if vector is to be generated
		during execution. May be left blank
		if vector already exists on a file.
21-22	IND(1)	Number of gap tests to be performed
		max=10
24	IND(2)	=0 do not perform runs test
		=1 perform runs test

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26	IND(3)	=0 do not perform pairs test
		=1 perform pairs test
28	IND(4)	=0 do not perform chi-square test
		=1 perform chi-square test
30	IND(5)	=0 do not calculate moments
		=l calculate moments
32	IND(6)	=0 do not perform runs above/below
		mean test
		=1 perform runs above/below mean test
34	IND(7)	=0 do not calculate autocorrelations
		=1 calculate autocorrelations
36	IND(8)	=0 do not perform Kolmogorov-
		Smirnov test
		=1 perform Kolmogorov-Smirnov test
37-40		not presently used
41-42	IFILE	Unit number of file where previously
		generated vector of pseudo-random
		numbers resides. Should be 0 or
		blank if numbers are to be executed
		at run time.
44	NPRNT	= 0 do not print pseudo-random vector
		= 1 print pseudo-random vector
45-80	TITLE(1)-	A user-supplied title which will be
	TITLE(9)	printed on the first page of output

.

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### 2. Variable Format Card

The variable format card is only read if the vector of pseudorandom numbers is to be read from an existing data file. If such is the case, this card is the FORTRAN FORMAT statement, without the statement number and word FORMAT that was used to write the previously generated vector to its data file. For example, if the file generated contains 50,000 random numbers in records of length 20 the statement that wrote these to the data file might have been

cc3 7 21

900 FORMAT(20F10.5)

In this instance, the variable format card would be

ccl 9

(20F10.5)

No card should be inserted in this position if the pseudo-random vector is generated at execution time.

#### 3. Test Parameter Cards

Certain of the statistical tests available require a control card to provide user specified parameters needed for the test. These tests are

- a) the gap test
- b) the pairs test
- c) the chi-square test

Each time one of these tests is to be performed its parameter card is read. For the tests specified in the header card, the respective parameter cards must therefore be present. The format of these cards for each of the above tests is as follows: Gap Test

The gap test performed by the program is the second one mentioned in Chapter 2, Section F. It tallies the number of consecutive observations in the sequence that do not fall between a user specified interval from a to b. The program has the capability of performing up to 10 simultaneous gap tests as indicated by IND(1). This number of cards (IND(1)) is needed. The format is as follows:

Gap	Test	Parameter	Card
-----	------	-----------	------

Card Column	Label	Description
1-5	CA	Lower end of gap interval
6-10	СВ	Higher end of interval
14-15	MXGAP	Maximum number of cells to
		record gap length; 0, 1, 2, MXGAP-1.

MXGAP  $\leq 10$ 

CA must be less than CB. Also, to insure a meaningful chi-square test on the distribution of gap lengths

 $NT*(CB-CA)^2(1-(CB-CA))^{MXGAP} \ge 5.$ 

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#### Pairs Test

The pairs test tallies adjacent pairs of pseudo-random numbers in a two-dimensional frequency table where the horizontal and vertical axes are divided into a user specified number of categories, say NCP. Thus there are NCP<sup>2</sup> total cells. The user can specify NCP or the program will calculate a desirable value using the Mann-Wald criterion described earlier. In either instance, however, a Pairs Test Parameter Card must be present if the Pairs Test has been specified. Its format is as follows:

Pairs Test Parameter Card

Card Column	Label	Description
1-3	NCP	Number of cells to appear on
		horizontal and vertical axes.
		Maximum 50.
		=0 program will calculate NCP
		using Mann-Wald criterion.

#### Chi-Square Test

The user must provide the number of cells for the tallying of the frequency distribution for the Chi-square test. As with the pairs test mentioned above, if no explicit specification is made the program will calculate the number of cells using the Mann-Wald criterion. The format for the Chi-square Test Parameter Card is as follows:

### Chi-Square Test Parameter Card

Card Column	Label	Description
1-3	NC	Number of cells for tally of
		frequency distribution.
		Maximum 500.
		=0 program will calculate NC
		using Mann-Wald criterion.

If the gap test, pairs test or chi-square test is not requested on the header card by the appropriate IND(i), its corresponding parameter card must not appear.

### D. Output

The standard output from the Uniform Random Number Evaluation includes the following:

- the number of observations in the vector of pseudo-random numbers
- the user supplied seed if the sequence was generated during execution
- 3. a listing of the random sequence (optional).

Output for each of the tests available in the program is as follows:

Gap Test

- the user specified gap interval
- the frequency distribution of observed and theoretical gap lengths from length 0 to MXGAP-1 and over

- the calculated  $\chi^2$  statistic and associated degrees of freedom

- the critical  $\chi^2$  value for 90% and 95% confidence levels Runs Test

- the frequency distribution of observed and theoretical run lengths
- the calculated  $\chi^2$  statistic and associated degrees of freedom - the critical  $\chi^2$  value for 90% and 95% confidence levels
- the Z-score for the test of the hypothesis  $H_{r}$ : r = E(r)

#### Pairs Test

- the number of intervals the horizontal and vertical axes have been divided into
- the end points of each interval and the frequency count of adjacent pairs in each grid
- the calculated  $\chi^2$  value and its associated degrees of freedom - the critical  $\chi^2$  value for the 90% and 95% confidence levels

#### Chi-Square Test

- for each cell the interval end points, observed and theoretical frequency counts
- the calculated  $\chi^2$  value and its associated degrees of freedom - the critical  $\chi^2$  value for the 90% and 95% confidence levels

# Moments

- the calculated and theoretical mean, second moment, third moment and variance

- the normalized deviate of the observed mean from the theoretical mean of .5

### Runs Above/Below Mean

- the frequency distribution of observed and theoretical run lengths
- the calculated  $\chi^2$  statistic and its associated degrees of freedom
- the critical  $\chi^2$  value for 90% and 95% confidence intervals

### Autocorrelations

- the calculated autocorrelations of the series for all lags up to the minimum of 50 and NT/10
- the 95% confidence interval for the theoretical autocorrelations of zero
- the number of observed autocorrelations which fall outside the 95% limits

#### Kolmogorov-Smirnov Test

The Kolmogorov-Smirnov test involves sorting the vector of pseudorandom numbers. Since the vector is handled in blocks of 10,000, each block of 10,000 is sorted and the test performed on the sorted vector of length 10,000. The results are shown for each block up to twenty, or 200,000 random numbers and are as follows

- the maximum and minimum (ZP and ZM) deviations of

the observed and theoretical distributions

- the probability of observing a ZP less than the one realized
- the probability of observing a ZM greater than the one realized

### E. The Program and Necessary Subroutines

The Uniform Random Number Evaluations Program consists of a main program and fifteen functions and subroutines. It requires 114 K bytes of core on an IBM/360 Model 65. A run to generate 50,000 uniform random numbers and perform all eight tests uses approximately 4 1/2 CPU minutes of which the generation of the random numbers uses about half of the total time.

The main program acts as a control module among the subroutines. It performs necessary bookkeeping as well as all input/output. The subroutines are the modules that perform all the statistical tests and they are called by the main program and by other subroutines. A list of the functions and subroutines, their calling sequence and a brief description are shown below.

- GAP2 (called by MAIN) tallies gap lengths in the random vector and records results in appropriate table.
- CHISQ (called by MAIN, RUNTS) calculates the chi-square statistic and degrees of freedom for a pair of observed and theoretical frequencies.
- TALLY (called by MAIN) tallies vector of observations into a frequency distribution.
- MOMNT (called by MAIN) calculates mean, variance, second and third moments of a vector.
- KOLMO (called by MAIN) sorts vector into ascending order and finds the maximum and minimum deviations between the empirical and theoretical distributions.

- RUNTL (called by MAIN) tallies the number of runs up and down in a vector.
- RUNTS (called by MAIN) computes the theoretical frequencies of runs up and down and calculates the  $\chi^2$  statistic (using CHISQ).
- PARTL (called by MAIN) tallies the occurrence of the adjacent paired coordinates in a vector.
- PARTS (called by MAIN) performs the Pairs Test on the frequency of pairs tallied in PARTL.
- CHSQD (called by MAIN) calculates the critical chi-square value for an alpha level and a given degrees of freedom
- GAUSD (called by CHSQD) calculates the deviate associated with the cumulative probability of a normal distribution.
- AUTOC (called by MAIN) calculates autocorrelations in a vector for up to fifty lags.
- SMIRN (called by MAIN) computes the limiting distribution function of the Kolmogorov-Smirnov statistic.
- MWALD (called by MAIN) computes the optimal number of classes for a chi-square test according to the Mann-Wald criterion.
  - RAN (called by MAIN) a user supplied function to generate uniform pseudo-random numbers.

A listing of the entire program and all functions and subroutines is shown in Appendix A.

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#### CHAPTER 4

# EVALUATING SELECTED UNIFORM RANDOM NUMBER GENERATORS

### A. Introduction

In this chapter, the results of applying the subject program to a number of frequently used uniform pseudo-random number generators are presented and discussed. Additionally the subject program was run on "random" sequences from three intentionally biased generators. A summary of the output from these tests is presented, along with relevant remarks. A complete set of the output reports is available upon request. A sample output report is shown in Appendix B.

### B. The Tested Random Number Generators

As previously mentioned, four frequently used uniform pseudo-random number generators were tested. The four selected and a brief description . of each is shown below:

 RAN - A function coded in FORTRAN supplied by Dr. C. E. Donaghey in the class I. E. 670, Operations Research - Digital Simulation, Fall 1972. The validity of the generator is supposedly machine independent. The code for RAN is as follows: FUNCTION RAN (NSEED)

NSEED = IABS (NSEED \* 655393)

RAN = FLOAT (MOD(NSEED, 33554432)) / FLOAT (33554432) RETURN

END

2. RANDU - A FORTRAN subroutine presented in the IBM Scientific Subroutine Package, p. 77. RANDU is used in PETROS, originally an IBM simulation game of the oil industry, which has since been substantially modified and improved by Gulf and is periodically presented to Gulf management as part of an executive training seminar. The subroutine coding for RANDU is as follows:

SUBROUTINE RANDU (IX, IY, YFL)

IY = IX \* 65539

IF (IY) 5,6,6

- 5 IY = IY + 2147483647 + 1
- 6 YFL = IY

**YFL = YFL \* .4656613E-9** 

RETURN

END

In its above form as a subroutine, RANDU, when used in conjunction with the evaluation program, would have to generate its sequence of random values externally to the test program. It would be appropriate to note here that with a few minor changes however, RANDU could be converted to a function program and the random sequence generated during execution of the test program. The converted subroutine (renamed RAN, as required) would be as follows: FUNCTION RAN (IX) IY = IX \* 65539 IF (IY) 5,6,6 5 IY = IY + 2147483647 + 1 6 RAN = IY IX = IY RAN = RAN \* .4656613E-9 RETURN

END

3. GGU1 - An assembler language uniform pseudo-random number generator developed and distributed by IMSL (International Mathematical and Statistical Libraries, Inc.). GGU1 generates a sequence, {R} of uniformly distributed numbers using a multiplier and a seed

where:

$$R_{i+1} = A * R_i$$
  $i = 0, 1, 2...$ 

where:

A is a constant initialized in GGU1,

R<sub>o</sub> is the input seed, a floating point number in the interval (0, 1).

4. GGU2 - An assembler language uniform pseudo-random number generator developed and distributed by IMSL. GGU2 is similar to GGU1, except that two multipliers and two seeds are used in the former whereas GGU1 uses a single multiplier and seed. In GGU2, each seed-multiplier continuation is used to produce a floating point deviate. The resulting random deviate is built using the characteristic (exponent) of one of the original deviates and "Exclusive OR" ing the two mantissas, securing, in a random manner that the resultant lies in the interval (0, 1).

Each of the above random number generators was used to generate random sequences of length 1000, 2500 and 5000. The initial seed(s) for each of the twelve runs (4 generators, 3 runs each) were selected from a table of random numbers. All tests available in the program were executed on each sequence. The results are summarized in Tables IV. 1 and IV. 2.

Generally speaking, all the generators did fairly well with respect to these tests. The one or two significant  $\chi^2$  values for the gap tests is not abnormal for the 30 tests on each generator as it only represents about a 5% incidence of failure. Both IMSL routines fared poorly on the Runs Test, exhibiting an excessive number of runs in the sequence of length 1000. RANDU revealed a poor distribution of run lengths above and below the mean for its sequence of length 1000.

All of the tests were identically specified with respect to the available user parameters. The Mann-Wald criterion was used for selecting the number of cells in the Pairs Test and Chi-square Test. The gap tests evaluated ten gap intervals from (.0, .1) through (.9, 1.) It would be advisable for an analyst considering using one of these pseudo-random

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# TABLE IV. 1 RESULTS OF GAP TESTS

# GENERATOR

	RAN				RANDU			GGU1			GGU2	
Length of Sequence (M)	1	2.5	5	1	2.5	5	1	2.5	5	1	2.5	5
Gap Interval	,	0 5	<b>F</b> 4	F (	14 0.4	2 0	2 4		14 E		<b>o</b> (	, ,
(.01)	• 6	8.5	5.4	5.6	14.9*	3.9	2.0	7.1	14.5	4.6	9.6	6.6
(.12)	1.7	11.5	4.6	4.0	9.3	3.7	2.7	8.4	8.1	5.8	8.3	9.9
(.23)	3.6	8.7	6.5	3.5	11.3,	6.1	2.1	7.1	10.7	2.1	9.1	10.7
(.34)	3.5	5.5	6.4	3.6	6.6	4.8	.9	16.5*	5.9	5.2	13.8	8.2
(.45)	4.7	7.4	3.9	.6	10.0	8.6	4.5	2.0	4.1	8.3*	7.1	7.1
(.56)	2.1	6.7	5.6	3.3	8.2	15.2*	3.5	10.3	13.6	3.4	5.7	13.5
(.67)	2.3	12.0	6.5	.0	12.5	6.8	9.0*	8.2	5.6	3.1	9.7	6.2
(.78)	2.4	8.4	11.7	4.9	4.5	7.6	2.1	3.2	13.3	2.6	6.1	4.9
(.89)	8.1*	5.7	7.2	5.1	10.5	10.6	2.6	9.6	8.4	2.1	16.8*	6.3
(.9 - 1.0)	3.0	4.3	10.0	5.3	7.4	11.0	3.7	7.6	13.0	2.8	6.4	3.6
Critical X <sup>2</sup>												
Alpha = .05	9.49	16.92	16.92	9.49	16.92	16.92	9.49	16.92	16.92	9.49	16.92	16.92
Alpha = $.10$	7.78	14.68	14.68	7.78	14.68	14.68	7.78	14.68	14.68	7.78	14.68	14.68

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\* Significant  $\chi^2$  value at 90% confidence level

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# TABLE IV.2

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# SUMMARY OF STATISTICAL TESTS ON FOUR UNIFORM <u>PSEUDO-RANDOM NUMBER GENERATORS</u>

# GENERATOR

		RAN				RANDU			GGU1			GGU2		
	Length of Sequence (M)	1	2.5	5	1	2.5	5	1	2.5	5	1	2.5	5	
	Test													
1)	Runs Test - X <sup>2</sup>	1.0	-	3.5	1.5	-	6.5	12.8**	-	3.7	<sup>8.9*</sup>	-	4.3	
	$( \approx = .05)$ $( \approx = .10)$	9.5 7.8		11.1 9.2	9.5 7.8		.11.1 9.2	9.5 7.8		11.1 9.2	9.5 7.8		11.1 9.2	
2)	Runs Test -													
,	Z-score	6	-1.2	.0	. 5	6	.1	-1.3	2	. 8	1.5	. 17	-1.0	
	$( \propto = .05)$	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	
	(∝=.10)	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	
3)	Pairs Test - χ <sup>2</sup> Critical values	54.1	94.2	109.2	45.5	91.2	100.1	36.7	91.6	104.6	40.4	80.1	82.7	
	(∝=.05)	65.2	101.8	123.2	65.2	101.8	123.2	65.2	101.8	123.2	65.2	101.8	123.2	
	(∝=.10)	60.9	96.6	117.4	60.9	96.6	117.4	60.9	96.6	117.4	60.9	96.6	117.4	
4)	Chi-Square													
	Test - $\chi^2$ Critical values	42.7	65.4	115.0	45.5	88.1	73.6	53.3	72.8	98.6	48.4	94.3	130.0	
	(∝ = <b>.</b> 05)	76.8	107.5	137.7	76.8	107.5	137.7	76.8	107.5	137.7	76.8	107.5	137.7	
	$( \propto = .10)$	72.2	102.1	131.6	72.2	102.1	131.6	72.2	102.1	131.6	72.2	102.1	131.6	

.

# TABLE IV.2 (Cont'd)

# SUMMARY OF STATISTICAL TESTS ON FOUR UNIFORM PSEUDO-RANDOM NUMBER GENERATORS

# GENERATOR

			RAN			RANDU			GGU1			GGU2	
	Length of Sequence (M)	1	2.5	5	1	2.5	5	1	2.5	5	1	2.5	5
	Test												
5)	Moments - Z -											*	
	score of mean Critical values	.7	.6	8	5	1.24	<b></b> 3	1.19	1.12	. 3	.3	-1.8	.2
	(∝=.05)	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96	1.96
	(∝=.10)	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65	1.65
6)	Runs Above/												
-	Below Mean – $\chi^2$	10.4	2.9	5.8	11.8	5.0	9.7	4.1	7.3	6.4	5.1	9.1	4.0
	Critical Values												
	(∝=.05)	12.6	15.5	16.9	12.6	15.5	16.9	12.6	15.5	16.9	12.6	15.5	16.9
	(∝=.10)	10.7	13.4	14.7	10.7	13.4	14.7	10.7	13.4	14.7	10.7	13.4	14.7
7)	Autocorrelations -									·			
	% Outside ± 95%	**		*							*		
	limits	81	2	8	2	0	2	6	2	4	12 <sup>*</sup>	6	4
8)	Kolmogorov- Smirnov Test - Max (Prob (ZP).												
	Prob (ZM))	.74	.18	.73	.34	.77	.02	.49	.82	.07	. 32	.88	.24

\* statistically significant difference at 90% level

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\*\* statistically significant difference at 95% level

number generators for a specific application, to retest the generator with the characteristics of that application in mind. Particulars to consider would be the number and length of gap intervals, the number of cells in the Chi-square and Pairs Test, the initial seed, NSEED, and the length of the random vector. These factors would obviously have a direct bearing on the meaningfulness of the tests in relationship to the validity of the simulation.

C. Intentionally Biased Generators

As mentioned above, the evaluation program was also run using three biased random number generators. The function RAN referred to earlier in this chapter was modified to produce non-random sequences of length 5000. The three biased generators can be characterized as follows:

 Correlated random numbers - each generated pseudo-random number in the sequence was correlated with the previously generated number using the relationship

 $x_{i+1} = .3x_i + .7 \text{ RAN (NSEED)}$  i = 1,2,... 4999 where

RAN (NSEED) is the call to the function RAN described in Section B of this chapter.

2. Gap between .8 and .85 - random values were generated by RAN
with all values in the interval (.8, .85) ignored. The resultant
vector thus consisted of 5000 values of which none were in the
mentioned interval.

3. Periodicity length of 1000 - RAN was used to generate 1000 pseudo-random values. This sequence was then replicated four times and appended to itself to yield a vector of 5000 pseudorandom values having a periodicity or cycle length of 1000.

The summarized results of these three tests are shown in Table IV. 3. Critical values are not shown in this Table, but are identical to the critical values shown in Table IV. 2 for the sequences of length 5000.

The program does quite well in the detection of the aberrated pseudorandom number generators. The correlated random number generator shows significant differences in all tests, except the Moments Test Z - score for the mean. However, although not shown in Table IV. 3, the variance and second and third moments of this sequence are showing substantial difference from their respective expected values. With 8% of the autocorrelations significant, it is also interesting to note the value of the autocorrelation for the first lag is .296. The values for lags two and three are . 098 and . 019 which exhibit the pattern of autocorrelations from an autoregressive time series. The "gapped" generator shows its aberrations exceptionally well in the Pairs Test and Chi-square Test. The gap in the interval (.8, .85) lowers the mean significantly and also causes suspicious results in the Runs Above/Below the Mean and the Kolmogorov-Smirnov Tests. The cycled generator shows significant  $\chi^2$  values in all Gap Tests, the Runs Test, Pairs Test, Chi-square Test and Runs Above/Below the Mean. It also shows statistical significance

# TABLE IV.3

# RESULTS OF TESTS ON BLASED GENERATORS

# GENERATOR

- 54 -

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		Correlated	Gap at (.8, .85)	Cycle length 1000
1)	% significant $\chi^2$ values for maximum	1007	1.011	100%
	of 10 Gap Tests ( $\alpha = .05$ )	100%	10%	100%
	(210)	10070	50%	100%
2)	Runs Test - $\chi^2$	118.9**	2.9	<b>2</b> 5.4**
3)	Runs Test - Z - score	-8.6**	-1.0	1.4
4)	Pairs Test - $\chi^2$	1939.2**	234.7**	570.**
5)	Chi-Square Test - $\chi^2$	1531.8**	341.7**	626.3**
6)	Moments - Z - score of mean	. 50	-4.96**	1.34
7)	Runs Above/Below Mean - $\chi^2$	134.2**	24.1*	48.9**
8)	Autocorrelations - % outside ± 95% limits	8*	14*	28**
9)	Kolmogorov-Smirnov Test - Max (Prob (ZP), Prob (ZM) )	1.00**	1.00**	. 99**

.

\* statistically significant difference at 90% level

\*\* statistically significant difference at 95% level

٠

with the high proportion of non-zero autocorrelations and a very small K-S probability of actually representing its supposed theoretical distribution.

# D. Conclusions

The subject program to evaluate uniform pseudo-random number generators provides a consistent yet flexible tool for the analysis of computer generated random sequences. Additional areas of study relating to and expanding upon the work done to this point could prove to be interesting and informative.

The program might be used to evaluate additional uniform random number generators that are frequently used. This could be done as a general comparative test, similar to the ones described in this paper, or as a specific test with a particular application of the random number generator in mind and the tests parameters selected for that one application.

A study to determine the sensitivity of the program and define its discriminatory ability with regard to valid and invalid generators would be useful. This study could proceed by sequentially altering a valid pseudo-random number generator with more subtle aberrations until the program was no longer able to distinguish the biased generator from the presumably unbiased one. The various tests included in the program could be ranked according to their ability to detect defective generators and which tests are most likely to detect certain common deficiencies (e. g. autocorrelation, cycling, subtle patterns in the generated sequence).

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The area of periodicity is one in which additional study might prove to be especially revealing. The theory presented in Chapter 1 detailing the relationships between multipliers, seeds and various congruential methods could be taken further, using the subject program as a means of evaluating possible alternatives. Along the lines of the cycling generator presented earlier in this chapter, the ratio of cycle length to length of the evaluated sequence might be varied to determine at what point cycling becomes apparent.

All of the above areas of additional study propose use of the subject program as it now exists. There are of course, a number of possible enhancements to the program which might also be considered. There are a number of additional tests which could be included in the program such as the maximum test, minimum test, poker test, triplets test and distance test. An option for the user to code his own test (called UTEST, for example) and link edit the code to the main program in a manner like RAN is now handled would be a valuable feature and would give the program virtually total flexibility.

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# APPENDIX A

# Source Code for the Program

```
DATE = 74160
RAN IV G LEVEL
                21
                                    MAIN
                                                                             11/07/
                    DATA SET MSHDAEVRAN AT LEVEL 039 AS OF 06/09/74
         С
               DIMENSION X(10000),KOUNT(10),CELLS(500),EXPCT(500),ANS(4)
               DIMENSION A(50,50), IND(10), IFOMT(20)
               DIMENSION CELLG(10), RUNS(8)
               DIMENSION KNTMN(10), AC(50), ZP(20), ZM(20)
               DIMENSION CELGP(10,10), CAG(10), CBG(10), MEG(10)
               DIMENSION KNTSV(10), TITLE(9)
               DATA IFOMT / (20F', 8.5) ,18**
                                                   1/
         С
         С
               WHICH TESTS ARE TO BE PERFORMED ARE SPECIFIED
         С
                     BY IND(I) = 0 OR
                                       1
                                            WHERE
         С
                       I = 1
                              GAP TEST
                              RUNS TEST
         С
                       I = 2
         С
                       I = 3
                              PAIRS TEST
                              CHI-SQUARE TEST
         С
                       I = 4
         С
                       I = 5
                              MOMENTS
         С
                              RUNS ABOVE/BELOW MEAN (GAP TEST ON (0,.5))
                       I = 6
         С
                       I = 7
                              AUTOCORRELATIONS
         C
                       I = 
                              KOLMOGOROV - SMIRNOV TEST
         С
         С
               IFILE = UNIT NUMBER OF DATA SET WHERE RANDOM VALUES
         С
                        ARE LOCATED
         С
         С
                           FOR NUMBERS TO BE GENERATED BY USER
                      = 0
         С
                           SUPPLIED FUNCTION RAN
         С
             1 READ(5,900,END=89000) NT,NSEED,IND,IFILE,NPRNT,TITLE
           900 FORMAT(2110,1212,9A4)
         С
         С
               SET SYSTEM LIMITS
         С
               MAXRN=10000
               KIN=5
               KOUT=6
               MXCLS=500
               MAXA=50
               MAXKN=10
               WRITE(KOUT,9001) TITLE,NT,NSEED
          9001 FORMAT(*1RANDOM NUMBER EVALUATION*,5X,9A4///*
                                                                  NT =*, 110/* NSEE
              1 = , 110)
               WRITE(KOUT,9002)
          9002 FCRMAT(//// TESTS REQUESTED!)
               IF (IND(1) .GE. 1) WRITE(KOUT, 9003) IND(1)
               IF(IND(2) .EQ. 1) WRITE(KOUT,9004)
               IF(IND(3) .EO. 1) WRITE(KOUT,9005)
               IF(IND(4) .EQ. 1) WRITE(KOUT,9006)
               IF(IND(5) .FG. 1) WRITE(KOUT,9007)
               IF(IND(6) .EQ. 1) WRITE(KOUT,9009)
               IF(IND(7) .EQ. 1) WRITE(KOUT,90091)
               IF(IND(8) .EO. 1) WRITE(KCUT,9008)
          9009 FORMAT( !
                           RUNS ABOVE/BELOW MEAN!)
         90091 FORMAT( !
                           AUTOCORRELATIONS *)
          9003 FOPMAT( !
                           9004 FORMAT( !
                           RUNS TEST !)
          9005 FORMAT( !
                           PAIRS TEST*)
          9006 FORMAT( !
                           CHI - SQUARE TEST )
          9007 FORMAT( !
                           MOMENTS!)
          9008 FORMAT( !
                           KCLMOGOROV - SMIRNOV TEST*)
         С
         С
               WILL ALL RANDOM NUMBERS FIT IN CORE?
```

- 60 -

1

4

5

6

7

8

9

0

1

2

3

4

5

6

7

8

9

0

1

2 3

4

5

6

7

8

9

0

3

4

5

```
- 10 -
RAN IV G LEVEL
               - 21
                                    MAIN
                                                       DATE = 74160
                                                                             11/07
               ESTABLISH NUMBER OF ITERATIONS NECESSARY
         С
         С
6
               NITER= (NT-1)/ MAXRN + 1
         C
         C
         С
         С
               IS DATA GENERATED BY RAN, IF SO PLACE
         C
               ON UNIT 2, PRINT DATA IF REQUESTED
         C
               IEND=MAXRN
               DO 50 I=1,NITER
               IF( I .EQ. NITER) IEND= NT- (I-1) * MAXRN
0
               IF( IFILE .NE. 0) GO TO 20
               DO 10 J=1, IEND
            10 X(J)=RAN(NSEED)
               WRITE( 2 , IFOMT) (X(J), J=1, IEND)
               GC TO 40
            20 IF(I .EQ.1) READ(KIN,9010) IFOMT
          9010 FORMAT(20A4)
            40 IF(NPRNT .EQ. 0) GO TO 50
               IF(IFILE .GT. 0) READ(IFILE, IFOMT, END=45) X
            45 IF(1.EQ. 1) WRITE(KOUT,901) NT
           901 FORMAT(1H1,110, RANDOM VALUES*)
               WRITE(KOUT,902) (X(K),K=1,IEND)
           902 FORMAT(1X,15F8.5)
            50 CONTINUE
         С
        С
               BEGIN TESTS
         С
               IF(IFILE .EQ.O) IFILE=2
               REWIND IFILE
               N=MAXRN
               DO 1000 I=1,NITER
               IF(I .EQ.NITER) N=NT-(I-1)*MAXRN
               READ(IFILE, IFOMT) (X(K), K=1,N)
        С
        С
               GAP TEST
        С
           60 IF(IND(1) .LE. 0 ) GO TO 100
               IF( I.GT. 1) GO TO 65
               NGT=IND(1)
              DO 61 J=1,NGT
           61 READ(KIN,903) CAG(J),CBG(J),MBG(J)
          903 FORMAT(2F5.0,15)
              DO 63 K1=1.10
              DO 63 K2=1,10
           63 CELGP(K1,K2)=0.
           65 DB 90 KK=1,NGT
              CA=CAG(KK)
              CB=CBG(KK)
              MXGAP=MBG(KK)
              IF(CA .LT. CB) GO TO 70
              WRITE(KOUT,904)
          904 FORMAT( IGAP TEST ./ !
                                      * * * INPUT ERROR * * **)
              WRITE(KOUT,905) CA,CB
          905 FORMAT(
                          CA .GT.CB'//* CA =*,F8.5,* CB =*,F8.5)
              IND(1) = -1
              GO TO 100
           70 IF (MXGAP .LE. 10) GO TO 80
              WRITE(KOUT,904)
```

7

8

9

1

2

3

4

5

6

7

8

9

0

1

2

3

5

7

3

9

11/07

```
WRITE(KOUT,906)
82
83
            906 FORMAT(
                            MXGAP .GT. 10 --- SET TO 10*)
٥4
                MXGAP=10
             80 DO 82 K=1,MXGAP
B6
             82 KOUNT(K)=0
                CALL GAP2(N,KOUNT,MXGAP,X,CA,CB,I,KNTSV(KK))
87
88
                DO 83 K=1,MXGAP
89
             83 CELGP(KK,K)=CELGP(KK,K)+KOUNT(K)
90
                 IF(I.NE. NITER) GD TO 90
91
                XTOT=0.
92
                DO 84 K=1.MXGAP
93
                XTOT=XTOT+CELGP(KK,K)
94
             84 CELLG(K)=CELGP(KK+K)
95
                WRITE(KOUT.9061) CA.CB
96
           9061 FORMAT("1GAP TEST"//" GAP INTERVAL =(",F7.4,",",F7.4,")")
97
                WRITE(KOUT,9062)
           9062 FORMAT(//5X, 'GAP LENGTH', 7X, 'OBSERVED', 4X, 'THEORETICAL')
98
99
                CBA=CB-CA
00
                PROB=CBA
                TP=0.
01
                DO 87 K=1,MXGAP
02
                K1 = K - 1
03
04
                 IF( K.LT. MXGAP) GO TO 85
                 PROB=1.-TP
05
             85 TP=TP+PROB
06
                EXPCT(K)=XTOT*PRCB
07
80
                WRITE(KOUT, 9063) K1, CELLG(K), EXPCT(K)
09
           9063 FORMAT(115,F15.0,F15.3)
                IF(K.EQ.MXGAP) WRITE(KOUT, 9064)
11
           9064 FORMAT("+",T16,"+")
12
                 PROB=PROB*(1.-CBA)
             87 CONTINUE
13
                WRITE(KCUT,9065) XTOT
14
           9065 FORMAT(10X, *TOTAL*, F15.0)
15
                CALL CHISO(CELLG, EXPCT, MXGAP, CS, IDF)
16
17
                CV05=CHSQD(.05,IDF)
                CV10=CHSQD(.10,IDF)
18
19
                WRITE(KOUT,9066) IDF,CS
20
                WRITE(KOUT,9067) CV05,CV10
21
           9066 FORMAT(//* CHI - SQUARE(*,14,* DF) =*,F9.2)
           9067 FORMAT(//* CRITICAL VALUE (ALPHA=.05) =*,F9.2,
22
                  /* CRITICAL VALUE (ALPHA=.10) =*,F9.2)
                1
23
                 IF(IDF .EQ. 0) WRITE(KOUT,9068)
           9068 FORMAT(/// * * * *
                                      NO CHI - SQUARE TEST CALCULATED * * * *
24
                1 / ONE EXPECTED CELL COUNT .LT. 1 OR THREE EXPECTED COUNTS .LT.
               2 * )
             90 CONTINUE
25
          C
          C
                RUNS TEST
          С
26
            100 IF(IND(2) .EQ. 0) GO TO 200
27
                 IF( I .GT. 1) GO TO 110
28
                NVAL=4
<u>9</u>
                 IF( NT .GT. 500) NVAL=5
D.
                 IF( NT .GT. 1000) NVAL=6
31
                 IF( NT .GT. 25000) NVAL=7
32
            110 CALL RUNTL (X,N,RUNS,I,NVAL)
33
                IF(I .NE. NITER) GO TO 200
                CALL RUNTS (RUNS, NT, EXPCT, CS, IDF, NVAL)
34
35
                WRITE(KOUT,9071)
```

11/07/

```
9071 FORMAT("IRUNS TEST"//5X, "RUN LENGTH", 7X, "OBSERVED", 4X, "THEORETIC
6
               1 * )
7
                XTOTO=0.
8
                XTOTT=0.
9
                DO 120 K=1,NVAL
0
                XTOTO=XTOTO+RUNS(K)
1
                XTOTT=XTOTT+EXPCT(K)
2
                WRITE(KOUT, 9072) K, RUNS(K), EXPCT(K)
3
           9072 FORMAT(115,F15.0,F15.3)
4
                IF ( K.EO. NVAL) WRITE(KOUT.9073) X1010.XTOTT
           9073 FORMAT(*+*,T16,*+*/10X,*TOTAL*,F15.0,F15.3)
5
6
            120 CONTINUE
7
                CV05=CHSQD (.05, IDF)
8
                CV10=CHSQD (.10, IDF)
9
                WRITE(KOUT,9066) IDF,CS
0
                WRITE(KOUT,9067) CV05,CV10
1
                IF(IDF .EQ. 0) WRITE(KOUT,9068)
2
                VAR=(16.*NT-29.)/90.
3
                Z = (XTOTO - XTOTT) / SORT(VAR)
4
                WRITE(KOUT,9074) Z
5
           9074 FORMAT(/// Z - SCORE (TOTAL RUNS) = ++F8+2)
         С
          С
                PAIRS TEST
         С
            200 IF(IND(3) .EQ. 0) GD TO 300
6
7
                IF(I .EQ.I) READ(KIN,907) NCP
8
            907 FORMAT(13,2F10.0)
9
                IF(NCP .EQ. 0) NCP=SQRT(FLOAT(MWALD(NT)))
0
                IF(NCP .LE.50) GD TO 220
1
                WRITE(KOUT,908)
2
            908 FORMAT("IPAIRS TEST",/" * * * INPUT ERROR * * *")
3
                WRITE(KOUT.909)
4
            909 FORMAT( ! NCP .GT. 50 --- SET TO 50 !)
5
                NCP=50
6
            220 CALL PARTL(X,N,NCP,A,MAXA,I)
7
                IF(I .NE. NITER) GO TO 300
                CALL PARTS(A, MAXA, NCP, CS, STDCS)
8
9
                WRITE(KOUT, 9091) NCP
           9091 FORMAT(*1PAIRS TEST*//* NO. OF INTERVALS =*,13)
0
1
                XST=0.
2
                XINT=1./NCP
3
                LS=1
4
                LF=NCP
5
                IF(NCP .GE. 11) LF=10
6
            240 WRITE(KOUT, 9092) (JP, JP=LS, LF)
7
           9092 FORMAT( INTERVAL
                                     FROM - TO
                                                   *,1018
8
                DO 250 K=1,NCP
9
                XFN=XST+XINT
0
                WRITE(KOUT, 9093) K, XST, XFN, (A(K, J), J=LS, LF)
1
           9093 FORMAT(19,1X,2F7.4,10F8.0)
2
                XST = XFN
3
            250 CONTINUE
4
                IF(LF .EQ. NCP) GO TO 270
5
                LS=LF+1
6
                LF=LF+10
7
                IF(LF .GT.NCP) LF=NCP
8
                XST=0.
9
                WRITE (KNUT, 9094)
0
           9094 FORMAT( 11)
1
                GO TU 240
```

MAIN

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```
RAN IV G LEVEL
           270 IDF=NCP*NCP-1
               WRITE(KOUT,9066) IDF,CS
               CV10=CHSQD(.10,IDF)
               CV05=CHSQD(.05, IDF)
               WRITE(KOUT,9067) CV05,CV10
         C
         С
           300 IF (IND(4) .LE. 0) GO TO 500
         С
               CHI-SQUARE TEST
         C
         С
               IF (I .EQ. 1) READ(KIN.907) NC
               IF(NC .EQ. 0) NC=MWALD(NT)
               IF(NC .LE. MXCLS) GO TO 310
               WRITE(KOUT,910)
           910 FORMAT( *1CHI-SQUARE TEST */*
                                             * * * INPUT ERROR * * **)
               WRITE(KOUT,911)
           911 FORMAT( * NC .GT. 500 --- SET TO 500*)
               NC=MXCLS
           310 XM=1./NC
               XD = XM
               CALL TALLY(X,N,CELLS,NC,XM,XD,I)
               IF(I .NE. NITER) GO TO 400
               DO 330 KK=1.NC
           330 EXPCT(KK)=NT*XD
         С
               CALL CHISO(CELLS, EXPCT, NC, CS, IDF)
               WRITE(KCUT,9111)
          9111 FORMAT('1CHI - SQUARE TEST'//' INTERVAL
                                                                     TO
                                                                          OBSERVED
                                                           FROM -
              1HEORETICAL*)
               XST=0.
               XINT=1./NC
7
               XTOT=0.
                DO 360 K=1,NC
9
                XTOT=XTOT+CELLS(K)
                XFN=XST+XINT
0
                WRITE(KCUT,9112) K,XST,XFN,CELLS(K),EXPCT(K)
1
          9112 FORMAT(19,2F7.4,F10.0,F12.2)
2
3
                XST = XFN
           360 CONTINUE
4
5
                WRITE(KOUT,9113) XTOT
6
          9113 FORMAT(4X, 'TOTAL', 14X, F8.0)
                WRITE(KOUT,9066) IDF,CS
7
                CV05=CHS0D(.05,IDF)
8
                CV10=CHSQD(.10,IDF)
9
                WRITE(KOUT,9067) CV05,CV10
0
                IF(IDF .EQ. 0) WRITE(KOUT,9068)
1
         С
         C
            400 IF(IND(5) .FQ.0) GO TO 500
2
                IC=2
13
                IF(I .EQ.NITER) IC=3
4
                IF(I .EQ.1) IC=1
5
                IF(NITER .EQ.1) IC=4
                CALL MOMNT(X,N,ANS,IC)
                IF(IC .LT.3) GO TO 500
8
                WRITE(KOUT,912)
9
            912 FORMAT( IMOMENTS // 22X, OBSERVED THFORETICAL )
0
                WRITE(KGUT,913) ANS
1
            913 FORMAT(016X, *MEAN*, F10.4, 8X, *.5000*/10X, *2ND MOMENT*, F10.4, 8X, *.
2
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133*/10X,*3RD MOMENT*,F10.4,8X,*.2500*/12X,*VARIANCE*,F10.4,8X,
       *.0833*)
     2
      ADJSD=SQRT(.0833333/NT)
      Z = (ANS(1) - .5) / ADJSD
      WRITE(KOUT,9131) Z
 9131 FORMAT(///* Z - SCORE (XEAR-MU) = *,F8.2)
C
       RUNS ABOVE / BELOW MEAN
С
С
  500 IF (IND(6) .EQ.0) GD TD 600
      CO=0.
      C5=.5
      MABMN=10
      IF (NT .LE. 3000) MABMN=9
      IF (NT .LE. 1500) MABMN=8
      IF (NT .LE. 1000) MABMN=7
      IF (NT .LE. 500)
                        MABMN=6
      CALL GAP2(N,KNTMN,MABMN,X,CO,C5,I,KTMSV)
      IF(I. NE. NITER) GD TO 600
      XTOT=0.
      DD 520 K=1,MABMN
      XTOT=XTOT+KNTMN(K)
  520 CELLG(K)=KNTMN(K)
      WRITE(KOUT, 9150)
 9150 FORMAT('IRUNS ABOVE/BELOW MEAN (.5)')
      WRITE(KOUT,9151)
 9151 FORMAT(///5X, 'RUN LENGTH', 7X, 'OBSERVED
                                                  THEORETICAL*)
      PR08=.5
      TP=0.
      DO 540 K=1,MABMN
      K1 = K - 1
      IF(K .LT. MABMN) GO TO 535
      PR08=1.0-TP
  535 TP=TP+PRCB
      EXPCT(K)=XTOT*PROB
      WRITE(KOUT,9063) K1,CELLG(K),EXPCT(K)
      IF(K .EQ. MABMN) WRITE(KOUT,9064)
      PROB=.5*PROB
  540 CONTINUE
      WRITE(KOUT,9065) XTOT
      CALL CHISQ(CELLG, EXPCT, MABMN, CS, IDF)
      CV05=CHSQD(.05,IDF)
      CV10=CHSQD(.10,IDF)
      WRITE(KOUT,9066) IDF,CS
      WRITE(KOUT,9067) CV05,CV10
      IF(IDF .EQ. 0) WRITE(KOUT,9068)
  600 IF(IND(7) .EQ.0) GO TO 700
      NLAG=50
      IF( NT/10 .LT. NLAG) NLAG=NT/10
      CALL AUTOC(X,N,NLAG,AC,I,NITER)
      IF(I.NE. NITER) GO TO 700
      WRITE(KOUT,9152)
 9152 FORMAT( 'IAUTOCORRELATIONS'//7X, 'LAG', 8X, 'AC')
      KAC=0
      SD=SQRT(1./NT)*2.
      DD 620 K=1,NLAG
      WRITE(KOUT,9153) K,AC(K)
      IF(ABS(AC(K)) .GT. SD) KAC=KAC+1
  620 CONTINUE
 9153 FORMAT(110,F10.3)
```

TRAN	IN (	LEVEL	21	MAIN		DATE	= 7416	0 11/07
98			WRITE(KOUT	,9154} SD,KAC				
99		9154	FORMAT(//	95% LIMITS ON	AUTCCORRELA	TIONS=	(+/-)"	,F6.3/ NO. AC
			ISERVED OUT	SIDE LIMITS= '	,14)			
		700	IF(IND(8)	•EQ.0) GO TO 1	000			
01			IF(I .GE.	21) GO TO 790				
02			CALL KOLMO	3(X,N,ZP(I),ZM(	I))			
03			XN=N					
04			ZP(I) = SQF	RT(XN)*ZP(I)				
05			ZM(I) = SQRI	F(XN)*ZM(I)				
06			IF(I .NE.	NITER) GO TO 1	000			
07		710	WRITE (KCU)	r,914)				
08		914	FORMAT( 1)	(OLMOGOROV - SM	IRNOV TEST /	//• IT	ER ND.	*,8X,*ZP*,8X,*Z
			1, PROB(2	ZP) PROB(ZM)')				
09			DO 720 K=	L,NITER				
10			CALL SMIR	N(ZP(K),PZP)				
11			ZMA=ABS(Z	4(K))				
12			CALL SMIRI	N(ZMA+PZM)				
13			WRITE(KOU	T,9141} K,ZP(K)	,ZM(K),PZP,F	PZM		
14		720	CONTINUE					
15		9141	FORMAT(I1	0,4F10.4)				
16			GO TO 100	0				
17		790	IF(I .EQ.	NITER) GO TO 71	.0			
18		1000	CONTINUE		•			
19			REWIND IF	ILE				
20			GO TO 1					
21		89000	CALL EXIT					
22			END					

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AN	IV	C	LEVEL	21		MAIN		DATE = 74	158	22
			С	DATA SUBROUTIN	SET MSHOAG	SAP2 AT NT,MXGAP,	LEVEL 004 X,A,E,IC,M	AS DF 05/ (SV)	24/74	
2				DIMENSION	HKNT(1),X(1	1)				
			С	THIS ROU	TINE FINDS	GAPS CF	THE LENG	THS 0,1,2,	,MXGAP-	2,
			С	>=MX0	AP-1 IN A S	SEQUENCE	CE INI IN	PUTS NUMBE	RS.	
			С	A GAP IS	THE LENGHT	OF CBSFR	VASTICNS 1	WHERE NO C	ESERVATION	
			С	IN THE RAN	ICE (A,E) IS	S RECORDE	D.			
3				IF(IC .G1	-1) GO TO 2	20			•	
÷				DO 10 I=1	,MXGAP					
5			10	KNT(I)=0						
5				KSV=1						
7			20	KR=KSV						
2				DO 50 J=1	• N					
)				IF(X(J)	LT. A) GD T	TP 30				
)				IF(Y(J)	LT. 9) 60 1	TO 40				
L			30	KR = KR + 1						
2				GO TO 50						
3			40	JF(KR .GT	- MXGAP) K	R=MXGAP				
+				KNT(KR) = 1	NT(KR)+1					
5				K <sup>D</sup> = 1						
5			. 50	CONTINUE						
7				KSV=KR						
3				RETURN						
)				END						

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# DATE = 74158 22/46/

AN	IV	G	LEVEL	21			MAIN		DATE =	74158	22/4
			с		DATA SET	MSHOAC	CHISQ AT	LEVEL 005	5 AS OF	05/18/74	
L				SUBRO	UTINE CH	ISOICFL	LS,EXP,	K,CS,IDF)			
_			С	THIS	PROGRAM (	CALCULA	TES THE	CHI-SCUAS	F STATI	STIC DF K	CFLLS
			č	WITH	CBSERVED	FREQUE	ENCY COU	NTS IN VEO	TTTE CEL	LS AND TH	FCFETICAL
			č	VALUE	S IN •EXI	>*.					
>			-	DIMEN	ISICN CEL	_S(1),5	EXP(1)				
3				KADJS	=0						
, +				CS=C.							
5				00 20	) I=1,K						
5				IF (F	XP(I) .G	F. 5) (	GO TO 10				
7				IF(E)	(P(I) .L5	.1) GO	TO 50				
3				KACJ	=KADJ5+1						
- 7				IF(KA	DJ5 .EP.	3) GC	TO 50				
D			10	CS=CS	E+(CELLS(	I)-EYP	(I))**2/	EXP(I)			
1			20	CONTI	ENUE						
2				IDF=	(-1						
3				PETUP	N	•					
4			50	0=20	•						
5				IDF=(	0						
6				RETU	<sup>&gt;</sup> N						
7				END							

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•.
с	DATA SET MSHDATALLY AT LEVEL 003 AS OF 03/18/74
	SUBROUTINE TALLY (X,N,CELLS,K,XMIN,XDELT,ICALL)
	DIMENSION X(1), CFLLS(1)
С	TALLIES VECTOP X OF LENGTH N INTO CELLS <xmin,xmin td="" to="" xmin+xcelt,<=""></xmin,xmin>
Ċ	XMIN+XDELT TO XMIN+2(XDELT),,XMIN+(K-2)XDELT TO XMIN+(K-1)XDEL
Ċ	AND $>(K-1)XDFLT$
č	ICALL =1 ON FIRST CALL
Č	ICALL #1 ON SUBSEQUENT CALLS
-	IF(ICALL .NE. 1) GO TO 10
	DC 5 I=1+K
5	CELLS(T)=0.
10	$DD 100 I = 1 \cdot N$
	TSUP = (X(T) - XMIN) / XDELT+2.
	IF(ISUE .GT.K) ISUE=K
	TF(TSUE .LE.O) ISUE=1
	CELLS(TSUB) = CELLS(TSUB) + 1
100	CONTINUE
100	PETURN
	FND

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DATF = 74158
                                     MAIN
PAN IV G LEVEL
                21
                    DATA SET MSHDAMOMNT AT LEVEL 004 AS DE 03/20/74
         С
               SUBROUTINE MEMNT (X,N,ANS,ICALL)
               DIMENSION X(1), ANS(1)
               THIS SUBROUTINE CALCULATES 1ST, 2ND, 3RD MOMENTS AND
         С
                THE VARIANCE OF A VECTOR OF LENGTH N.
         С
                  ANS(1) = M = AN
         C
         С
                  ANS(2) = 2NE MOMENT
                   ANS(3) = 3RD MOMENT
         С
                  ANS(4) = VARIANCE
         С
         С
                   ICALL = I FIRST PASS
         С
                  ICALL = 2 SUCCEEDING PASSES EXCEPT LAST PASS
         С
                   ICALL = 3 LAST PASS
         С
         С
                SERC ANS ON 1ST PASS
         С
                IF(ICALL .GT.1 .AND. ICALL .NE. 4) GO TO 10
               DO 5 I=1,4
             5 ANS(I)=0.
               NTOT=0
            10 DD 100 KK=1,N
                XI=X(KK)
                ANS(1) = ANS(1) + XI
                AMS(2) = AMS(2) + XI \neq XI
                ANS(2)=/NS(3)+XI**3
           100 CONTINUE
                NTOT=NTOT+N
                IF (ICALL .LT. 3) RETURN
                 CALCULATE FESULTS
         С
                ANS(1)=ANS(1)/NTOT
                ANS(2)=AMS(2)/NTOT
                ANS(3)=ANS(3)/NTCT
                ANS(4) = ANS(2) - ANS(1) + 2
                RETURN
                END
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RAN IV G LEVEL
                21
                                     MAIN
                                                        DATE = 74158
                                                                               22/46/
         С
                     DATA SET MSHOAKOLMO AT LEVEL 002 AS DE 05/23/74
                SUBROUTINE KOLMO (X,N,ZPLUS,ZMIN)
         С
                THIS SUBROUTINE TESTS THE DIFFERENCE BETWEEN AN
                 EMPIRICAL AND THEORECTICAL DISTRIBUTION USING THE
         С
         С
                KOLMCGOROV-SMIRNOV GOCONESS OF FIT TEST.
         С
         С
                REFERENCE JBM - SSP COPYPIGHT 1968 PP. 63-64
               DIMENSION X(1)
         С
         С
                 SCRT X INTO ASCENDING ORDER
         С
               M=N
            20 M=M/2
               IF(M .EQ. C) GD TO 40
               K = N - M
               J=1
            41 I=J
            49 L=I+M
               IF(X(I)-X(L)) 60,60,50
            50 XS=X(I)
               X(1) = X(L)
               X(L) = YS
               I = I - M
               IF(I-1) 60,49,49
            60 J = J + 1
               IF(J-K) 41,41,20
            40 CONTINUE
         С
         С
                FIND MIN AND MAX DEVIATION
         С
               NM1=N-1
               XN=N
              ZPLUS=-1000.
               ZMIN=+1000.
               IL=1
             6 DO 7 I=IL,NM1
               J = I
               IF( X(J) .NF. X(J+1)) GO TO 9
             7 CONTINUE
             N=L 9
             9 IL=J+1
               FS=FLCAT(J)/XN
               IF (X(J) .GT. 0) GD TO 23
               Y=0.
               GC TC 27
            23 IF(X(J) .LT. 1.) GC TC 25
               Y=1.
               GP TP 27
            25 Y = X(J)
            27 DIFF=Y-FS
               IF(DIFF .GT. ZPLUS) ZPLUS=DIFF
               IF(DIFF .LT. ZMIN) ?MIN=DIFF
               IF(IL-N) 6,8,28
            28 RETURN
               END
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                                                                             221441
                                                       DATE = 74158
                                    MAIN
RAN IV G LEVEL
                21
                    DATA SET MSHDAPUNTL AT LEVEL OOF AS DE 05/23/74
         С
               SUBROUTINE RUNTL (X,N,RUNS,ICALL,NVAL)
               DIMENSION X(1), FUNS(1)
                THIS SUPROUTINE TALLIES THE NUMBER OF RUNS OF
         С
               LENGTH I, I=1,8 . RUNS OF LENGTH >= TO 8 ARE TALLIED IN PUNS(9)
         С
                 THE FIRST AND LAST RUN TOF THE TOTAL SEQUENCE ARE NOT TALLIFD.
         С
         С
               IF(ICALL .NE.1) GD TD 50
         С
               ZERO CUT RUNS
               DO 5 I=1.8
             5 RUNS(I)=0.
               IGNOPE 1ST RUN
         С
              IS FIFST FUN UP OR DOWN
         С
               IUPS=+1
               IF(X(2)-X(1) - LT - 0) IUPS = -1
               DO 10 I=3.N
               IUP=+1
               IF(X(I)-X(I-1) . LT. 0) IU^{p=-1}
               IF(IUPS .- C. IUP) GO TO 10
               IUPS=IUP
               NSTART=I+2
               CO TO 20
            10 CONTINUE
               STOD 59
            20 KNT=1
               XSAVE=X(NSTART-1)
               GO TO 100
            50 1UP=+1
               NSTAPT=2
               IF(X(NSTAFT-1)-XSAVE .LT.0) IUP=-1
               IF(IUPS .FC. IUP) GC TC 80
               IUPS=IUP
               IF (KNT .GT. NVAL) KNT=NVAL
               RUNS(KNT)=RUNS(KNT)+1
               KNT=1
               GO TO 100
            80 KNT=KNT+1
           100 DD 200 I=NSTART,N
               IUP=+1
               IF(X(I)-Y(I-1) .LT.0) IUP=-1
               IF(IUPS .FO.IUP) GO TO 180
               IUPS=IUP
               IF (KNT .GT. NVAL) KMT=NVAL
               RUNS(KNT)=RUNS(KNT)+1
               KNT=1
               GD TO 200
           180 KNT=KNT+1
           200 CENTINUE
               XSAVF=X(N)
               RETURN
               FND
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RAN	IV	Ŀ	LEVEL	21	MAIN	DATE = 74158	22/46
1			с	DATA SET MSHO SUBROUTINE RUNTS (	ARUNTS AT LEVEL CO7 RUNS,N,F,CS ,IDF,NVA	AS DF 05/24/74	
			C	THIS SUEROUTINE C	OMPUTES THE CHI-SOUA	ARE STATISTIC FOR THE	FUNS
			č	TALLIED IN SUBPOUT	INE RUNTL.	•	
			Č				
			č	REFERENCE IEM SYST	EMS JOURNAL 1969 PP	. 136-46	
2			-	DIMENSION RUNS(1),	E(1)		
-			С	EXPECTED NUMBER OF	RUNS		
3				DENOM=6.			
4				NV1=NVAL-1			
5				DO 100 I=1,NV1			
6				SUM1=N*(I*I+3*I+1)			
7				SUM2=I**3+3*I*I-I-	4		
3				DENCM=DENCM*(I+3.)			
9			100	E(I) = 2 * (SUM1 - SUM2)	) ZDENOM		
0				$E(NVAL) = 2 \cdot * (N \times (NVA))$	(+1.)-(NVAL**2+NVAL	-1.1	
1				E(NVAL) = E(NVAL)/CE			
2				CALL CHISC(RUNS, E,	NVAL, US, IUF)		
3				RETURN			
4				END			

1

с	DATA SET MSHDAPARTE AT LEVEL 001 AS DE 03/11/74
	SUPPOUTINE PARTL (X,N,K,A,TA,ICALL)
	DIMENSION X(1).A(IA,IA)
С	THIS PROGRAM TALLIES THE OCCURENCE OF THE PAIRED COORDINATES
Ċ	X(I),X(I+1) OF A SEQUENCE OF PSEUDO-RANDOM
č	NUMBERS ON (0,1) INTO A K X K ARRAY
Ċ	IF ICALL = = 1 ROUTINE INITIALIZES A MATRIX.
Č	
	IF(ICALL .NF.1) GD TO 100
	DO 10 I=1,IA
	DC 10 $J=1, IA$
•	10 A(I,J)=0.
10	00 DO 150 I=1,N,2
	$J = K \neq X (I) + 1$
	M=K*X(I+1)+1
1	50 A(J,M) = A(J,M) + 1.
	RETURN
	END

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	с	DATA SET MSHCAPARTS AT LEVEL 003 AS OF 03/23/74
1		SUBPRUTINE PARTS(A, IA, K, CS, SIDES)
2		DIMENSION A(IA,IA)
	С	THIS PROGRAM PERFORMS THE PAIRS TEST ON A PREVIOUSLY
	c	TALLIED SEQUENCE OF PSEUDO-RANDOM NUMPEP (USING PAPTL).
3	-	TCT=0.
4		DD 50 I=1,K
5		DO 50 J=1,K
6	50	TOT=TOT+A(I,J)
7		E=TOT/K**2
8		• • • • • • • • • • • • • • • • • • • •
9		DD 100 I=1,K
0		PC 100 J=1,K
1	100	CS=CS + (A(I,J)-E)**2/E
2		F=K*K-1
3		STDCS=(CS-F)/SCRT(2.*F)
4		RETURN
5		END
•		

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RAN IV G LEVEL
               21
                                   MATN
                                                     DATE = 74160
                                                                          11/07/
                    DATA SET MSHDACHSQD AT LEVEL 002 AS OF 06/09/74
        С
              FUNCTION CHSQD (P,N)
1
        С
               THIS FUNCTION IS USED TO EVALUATE THE QUANTILE
              AT A GIVEN PROBABILITY LEVEL, P, FOR THE CHI-SQUARE
        С
        С
               DISTRIBUTION WITH N DEGREES OF FREEDOM.
        С
        C
               REFERENCE COMM. OF THE ACM VOL 16 NO 8 PP. 483-5
        С
2
              DIMENSION C(21), A(19)
3
              DATA C/1.565326E-3,1.060438E-3,-6.950356E-3,
             *
                -1.323293E-2,2.277679E-2,-8.986007E-3,
             *
                -1.513904E-2.2.530010E-3.-1.450117E-3.
             *
                5.169654E-3,-1.153761E-2,1.128186E-2,
                2.607083E-2,-0.2237368,9.780499E-5,
             *
             *
                -8.426812E-4,3.125580E-3,-8.553069E-3,
                1.348028E-4,0.4713941,1.0000886/
             *
4
              DATA A/1.264616E-2,-1.425296E-2,1.400483E-2,
             *
                -5.886090E-3,-1.091214E-2,-2.304527E-2,
             *
                3.135411E-3,-2.728484E-4,-9.699681E-3,
                1.316872E-2,2.618914E-2,-0.2222222,5.406674E-5,
             *
             *3.483789E-5, -7.274761E-4, 3.292181E-3,
             * -8.729713E-3,0.4714045,1./
5
              IF(N-2) 10.20.30
6
           10 CHSQD=GAUSD(.5*P)
7
              CHSOD=CHSOD*CHSOD
8
              RETURN
Q
           20 CHSQD= -2.*ALCG(P)
0
              RETURN
           30 F=N
              F1=1./F
2
3
              T = GAUSD(1 - P)
              F2=SORT(F1)*T
4
5
              IF(N .GE. (2+INT(4.*ABS(T))) GO TO 40
6
              +C(5))*F2+C(6))*F2+C(7))*F1 + ((((((C(8)+C(9)*F2)*F2)
              1
             2
                 +C(10))*F2+C(11))*F2+C(12))*F2+C(13))*F2+C(14)))*F1 +
             3
                 ((((((C(15)*F2+C(16))*F2+C(17))*F2+C(18))*F2
                +C(19))*F2+C(20))*F2+C(21)
             4
7
              GO TO 50
           40 CHSQD={((A{1}+A{2}*F2)*F1+(({A{3}+A{4}*F2}*F2
8
                +A(5))*F2+A(6)))*F1+(((((A(7)+A(8)*F2)*F2+A(9))*F2
              1
             2
                +A(10))*F2+A(11))*F2+A(12)))*F1+(((((A(13)*F2
             3
                +A(14))*F2+A(15))*F2+A(16))*F2+A(17))*F2*F2
                +A(18))*F2+A(19)
             4
9
           50 CHSQD=CHSQD*CHSQD*CHSQD*F
0
              RETURN
1
              END
```

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3

4

5

6

7

8

9

0

1

2

3

THIS FUNCTION CALCULATES THE NORMAL DEVIATE FOR THE VALUE P OF THE CUULMULATIVE PROBABILITY DISTRIBUTION. ALGORITHM FROM HASTINGS, CECIL, JR. APPRCX FOR DIGITAL COMPUTERS DATA A0, A1, A2/2.515517, .802853, .010328/ DATA 81,82,83/1.432788,.189269,.001308/ B=P IF(B .GT. .5) B=1.-B U1 = -ALOG(B)U=SORT(2.\*U1) U2=U\*U **U3=**U2\*U GAUSD=U-(A0+A1\*U+A2\*U2)/(1.+B1\*U+B2\*U2+B3\*U3) IF(P .LT. .5) GAUSD=-GAUSD RETURN END

- 77 -

MAIN

22140	2	2	1	4	6	/
-------	---	---	---	---	---	---

```
DATA SET MSHDAAUTOC AT LEVEL 004 AS DF 05/18/74
         С
                SUBPOUTINE AUTCC(X,N,LAG,AC,IC,NITEP)
1
                DIMENSION X(1)
                DIMENSION AC(1), XSAVE(50)
                XBAP = .5
4
                IF(IC .GT. 1) GD TD 50
5
                NT = N
6
7
                CO=0.
                DO 10 I=1,LAG
8
ò
             10 AC(I)=0.
                GO TO 200
0
             50 NT=NT+N
1
2
                DO 100 K=1,LAG
3
                NK=LAG-K+1
4
                 DO 80 J=1,K
                 AC(K) = AC(K) + (XSAVE(NK) - XEAR) * (X(I) - XEAR)
5
6
             80 NK=NK+1
            100 CONTINUE
7
            200 DC 300 K=1,LAG
8
ò
                NK=N-K
                 DD 300 I=1,NK
0
                 NKI=I+K
1
                 LC(K) = LC(K) + (X(I) - XBAR) + (X(NKI) - XBAR)
2
                 IF(K \cdot EQ \cdot 1) CO = CO + X(I) * X(I)
3
            300 CENTINUE
4
5
                 CO=CO+X(N)*X(N)
                 DD 400 I=1,LAG
6
2
                 MLI=N-LAG+I
            400 XSAVE(I)=X(NLI)
                 IF(IC .NF. NITER) RETURN
9
                 CO=(CO-NT*XEAE*XPAE)/NT
0
                 DR 450 K=1,LAG
1
2
            450 AC(K)=AC(K)/(NT*CO)
                 FETUPN
3
4
                 END
```

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AN	IV	Ģ	LEVEL	21		MAIN		DATE =	= 74158
			c c	DATA SUBROUTIN	SET MSHDA E SMIRN(X,	SMIPN AT L Y)	FVEL 003	AS OF	05/11/74
				THIS SUB FUNCTION REF. I N	ROUTINE CO N DE THE K B M SSP	MPUTES THE CLMOGOROV- PP. 66-67	LIMITING SMIFNIV S	C DISTR STATIST	IBUTION FIC.
<b>&gt;</b>			C	IF(x27)	1,1,2				
-			1	Y=0.					
+				RETURN					
5			2	1=(X-1.) 3	3,6,6				
· ·			3	Q1=FXP(-1	.233701/X*	**2)			
7				02=01*01					
2				C4=02*02					
2				C8=04*04					
)				IF(08 .	LT. 1.E-25	5) 08=0.			
l				Y=(2.5066	28/X)*Q1*(	(1.+08*(1.+	((8 <u>0</u> *39		
2				RETURN					
3			6	IF(X -3.1	) 8,7,7				
t			7	Y=1.					
5				PETURN					
5			8	01=FXP(-2	*X*X)				
7				02=01*01					
3				64=62*62					
7				08=04*04					
)				Y=12.*(	01-04+08*(	(01-08))			
L				RETURN					
2				END					

TRAN	IV	G	LEVEL	21	MA	IN	DATE = 74158	
			с	<b>F</b> 1016	DATA SET MSHOAMWA	LD AT LEVEL	001 AS OF 05/25/74	
01			-	FUNC	IICN MWALE(N)			
			C					
			С	THIS	FUNCTION COMPUTES	THE CPTIMA	L NUMPER CE CLASS	
			С	FCR	A CHI-AQUARE TEST	ACCOPPING	TO THE MANN-WALD CETTERT	A
			С				· · · · · · · · · · · · · · · · · · ·	
02				8=4.				
03				CCRIT	T=1.645			
04				XN=N-	-1			
05				MWALT	D=E*(2.*XN*XN/CCP)	[]**2)**.2		
06				RETUR	₹N			
07				END	·			

,

RAN

RAN IV G LEVEL 21



FUNCTION RAN(NX) RAN=0.0 RETURN END

#### APPENDIX B

# Sample Output Listing

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#### NT = 5000

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NT = 5000 NSEED = 95605

TESTS RECUESTED GAP TESTS - 10 RUNS TEST PAIRS TEST CHI - SQUAPE TEST MOMENTS RUNS ABOVE/EELOW MEAN AUTOCODEFLATIONS KOLMOGOROV - SMIPNOV TEST

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## GAP TEST

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GAP INTERVAL =( 0.0 , 0.1000)

C 4 D	LENCTH	OBSERVED	THEORETICAL
GAP		5.7.	51.900
	0	F.4	46.710
		23	42.039
	2	. C	37.835
	5	70.	34.052
		28	30.646
	5 6	21.	27.582
	7	27.	24.824
	í C	10.	22.341
	( ()+	201.	201.072
:	TOTAL	£19.	

CHI - SQUARE( 9 DE) = - 5.44

CRITICAL	VALUE	(ALPHA=.CT)	H	16.92 14.68
CRITICAL	VALUE			

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GAP INTERMAL = ( 0.1000, 0.2000)

GAP	LENGTH	CESEPVED	THEORETICAL
0711	0	54.	48.700
	1	49.	43.830
	2	39.	39.447
	3	31.	35.502
	4	28.	31.952
	5	29.	28.757
	6	23.	25.881
	7	18.	23.293
	8	25.	20.964
	9+	191.	188.674
	TOTAL	487.	

CHI - SQUARE( 9 DE) = 4.58

CRITICAL	VALUE	(ALPHA=.05)	=	16.92
CRITICAL	VALUE	(ALPPA=.10)	=	14.68

## GAP TEST

# GAP INTERVAL =( 0.2000, 0.2000)

GAP	LENGTH	DBSERVED	THEOPETICAL
	0	47.	50.200
	1	41.	45.180
	2	43.	40.662
	2	34.	36.596
	4	29.	32.936
	Ę	30.	29.643
	6	28.	26.678
	7	32.	24.019
	r F	15.	21.609
	Q+	203.	194.486
	TOTAL	502.	

CHI - SQUARE( 9 DF) = 6.50

CRITICAL	VALUE	(ALPHA=.05)	Ξ	16.92
CRITICAL	VALUE	(ALPHA=.10)	=	14.68

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#### GAP TEST

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GAP INTERVAL =( 0.3000, 0.4000)

GAP LENGTH	DESERVED	THEORETICAL
O	59.	52.800
1	44.	47.520
2	47.	42.768
3	38.	38.491
4	43.	34.642
5	29.	31.178
6	24.	28.060
7	21.	25.254
3	21.	22.729
9 <b>+</b>	102.	204.558
. TOT/L	528.	

CHI - SOUARE( 9 DF) = 6.38

CRITICAL	VALUE	(ALPHA=.05)	Ξ	16.92
CRITICAL	VALUE	(ALPHA=.10)	=	14.68

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GAP INTERVAL =( 0.4000, 0.5000)

GAP LENGTH	OBSERVED	THECSETICAL
С	44.	47.100
1	44.	42.390
2	36.	38.151
3	32.	34.336
4	33.	30.902
5	22.	27.812
6	31.	25.031
7	26.	22.528
۶	20.	20.275
· 9+	183.	182.475
TOTAL	471.	

 $CHI - SQUARE( \circ DF) = 3.87$ 

CRITICAL	VALUE	(ALPHA=.05)	=	16.92
CRITICAL	VALUT	(ALPHA=.10)	=	14.68

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GAP INTERVAL =( 0.5000, 0.6000)

CAP LENGTH	DESERVED	THEORETICAL
0	44.	50.100
1	45.	45.090
2	39.	40.581
3	47.	36.523
4	30.	32.871
5	25.	29,583
6	26.	26.625
7	22.	23.963
8	25 •	21.566
9+	108.	194.008
TOTAL	501.	

CHI - SQUARE( 9:0F) = 5.57

CRITICAL	VALUE	(ALPHA=.05)	Ξ	16.92
CRITICAL	MALU-	(ALPHA=.1C)	=	14.68

#### GAP TEST

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#### - 91 -

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### GAP INTERVAL = ( 0.6000, 0.7000)

GAP	LENGTH	. CRSERVED	THEORETICAL
	0	51.	52.300
	1	57.	47.070
	2	35.	42.363
	3	43.	38.127
	4	36.	34.314
	5	23.	30.883
	6	30.	27.794
	7	23.	25.015
	8	16.	22.513
	Q+	199.	202.621
	TOTAL	523.	

CHI - SOUARE( 9 DF) = 6.54

CRITICAL	MALUE	(ALPHA=405)	=	16.92
CRITICAL	VALUE	(ALPH#=.10)	=	14.68

#### GAP TEST

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GAP INTERVAL = ( 0.7000, 0.8000)

GAP LENGTH	CESEPVED	THEORETICAL
0	51.	52.300
1	58.	47.070
. 2	42.	42.363
3	36.	38.127
4	24.	34.314
5	27.	30.883
E	22.	27.794
7	32.	25.015
3	20.	22.513
C+	191.	202.621
TOTAL	523.	

CHI - SQUARF( 9 DF) = 11.74

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CRITICAL	VALUE	(ALPHA=.05)	=	16.92
CRITICAL	VALUE	(ALPHA=.10)	Ξ	14.68

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GAP INTERVAL = ( 0.8000, 0.9000)

GAP LENGTH	CRSERVED	THEOPETICAL
С	38.	45.400
1	37.	40.860
2	37.	36.774
<b>1</b>	34.	33.097
۲.	27.	29.787
5	20.	26.808
£	20.	24.127
7	26.	21.715
8	23.	19.543
C+	192.	175.889
TGTAL	454.	

CHI - SQUARE( 9 DF) = 7.23

CRITICAL	VALUE	(ALPHA=.05)	=	16.92
CRITICAL	VALUE	(ALPHA=.10)	=	14.68.

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GAP INTERVAL = ( 0.9000, 1.0000)

CAP	LENGTH	CBSERVED	THEORETICAL
	C	60.	49.200
	1	47.	44.280
	2	42.	39.852
	3	32.	35.867
	4	31.	32.280
	5	23.	29.052
	6	21.	26.147
	7	17.	23.532
	3	15.	21.179
	<u>+</u>	204.	100.611
	TOTAL	402.	

CHI - SOUARE(9 DF) = 9.95

CRITICAL	VALUE	(ALPHA=.05)	Ξ	16.92
CRITICAL	VALUE	(ALPHA=.1C)	=	14.68

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	RUN LENGTH	DESERVED	THEORETICAL
	1	2047.	2083.417
·	2	.338	916.433
	3	277.	263.758
	4	60.	57.498
	5	10.	10.159
	6+	0.	1.734
	TOTAL	3332.	3332.099

CHI - SOUARE(5 DF) = 3.48

CRITICAL VALUE (ALPHA=.05) = 11.07 CRITICAL VALUE (ALPHA=.10) = 9.24

Z = SCORF (TOTAL PUNS) = -0.03

PAIRS TE

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NO. OF I	NTERVALS = 10										,
INTERVAL	FRCM - TO	1	2	3	L;	5	6	7	8	Ģ	10
1	0.0 0.1000	22.	21.	27.	27.	24.	25.	22.	16.	20.	25.
2	0.1000 0.2000	18.	25.	20.	24 .	24.	12.	26.	30.	14.	28.
3	0.2000 0.3000	34.	28.	21.	32.	25.	28.	21.	31.	20.	27.
4	0.3000 0.4000	30.	23.	23.	29.	22.	28.	2°.	25.	25.	- 24.
5	0.4000 0.5000	10.	27.	14.	23.	21.	22.	26.	32.	26.	25.
6	0.5000 0.6000	21.	23.	30.	27.	27.	24.	18.	20.	22•	24.
7	0.6600 0.7600	34.	24.	26.	26.	25.	29.	23.	32.	32.	33•
9	0.7000 0.2000	35.	24.	21.	30.	35.	31.	24.	23.	19.	34.
C	0002.0 0003.0	36.	25.	21.	25.	21.	21.	22.	23.	21.	23.
10	0.5000 1.0000	28.	26.	27.	17.	16.	25.	27.	15.	16.	26.0

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CHI - SCUARE( 99 CF) = 109.20

CRITICAL VALUE (ALPHA=.05) = 123.23 CRITICAL VALUE (ALPHA=.10) = 117.41

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INTERVAL	FROM	- то	PRSERVED	THEOPETICAL
1	0.0	0.0088	45.	44.25
2	3300.0	0.0177	57.	44.25
3	0.0177	0.0265	46.	44.25
4	0.0765	0.0354	42.	44.25
5	0.0354	0.0442	37.	44.25
6	0.0442	0.0531	42•	44.25
7	0.0531	0.0615	38.	44.25
8	0.0619	0.0708	53.	44.25
9	0.0708	0.0796	53.	44.25
10	0.0796	0.088F	56.	44.25
11	0.0885	0.0973	36.	44.25
12	0.0973	0.1062	42.	44.25
13	0.1062	0.1150	44.	44.25
14	C.1150	0.1220	44.	44.25
15	0.1229	0.1327	3 <b>9</b> •	44.25
16	0.1327	0.1416	40.	44.25
17	0.1416	0.1504	39.	44.25
18	0.1504	0.1593	ÉO.	44.25
19	0.1593	0.1681	37.	44.25
20	0.1691	0.1770	41.	44.25
21	0.1770	0.1858	45.	44.25
22	0.1855	0.1947	48.	44.25
23	0.1947	0.2035	46.	44.20
24	0.2035	0.2124	34.	44.25
25	0.2124	0.2212	36.	44+20
26	0.2212	0.2301	45.	44.25
27	0.2301	0.2389	41.	44.20
28	0.2389	0.2478	29.	44.20
29	0.2475	0.2566	50.	44+42 77
30	0.2566	0.2655	57 • 57	44.25
31	0.2655	0.2743	24.	44.25
32	0.2143	0.2832	· c	44.25
33	0.2822	0.2920		44.25
34		0.2002	74.	44.25
35 57		0.2196		44.25
30	$0.0.20^{-7}$	0.3274	45.	44.25
20		0 - 24	55	44.25
20	0.521-	× 0.3451	48.	44.25
40	0.3451	0.3540	52.	44.25
	0.354(	0.3628	37.	44.25
42	0.2628	0.3717	36.	44.25
4	3 0.3717	7 0.3805	58.	44.25
44	0.3805	C.3894	<b>F2</b> .	44.25
49	5 0.3804	0.3982	48.	44.25
46	5 0.3982	2 0.4071	45.	44.25
4	7 0.4073	1 0.4159	41.	44.25
41	0.415	0.4248	21.	44.25
4	9 0.4248	e 0.4336	36.	44.25
5	0.4330	6 0.4425	41.	44.25
5	1 0.442	5 0.4513	46.	44.25
51	2 0.451	3 0.4602	44.	44.25
5	3 0.460	2 0.4690	36.	44.25
5	4 0.460	0.4770	47.	44.25
5	5 0.477	o 0.4867	53.	44.25
5	6 C.48E	7 0.4456	46.	44.25
5	7 0.405	6 0.5044	48.	44.25
<u>5</u> .	8 0.504	4 0.5133	42.	44.25

CRITICAL MALUE (ALPHA=.05) = 137.71 CRITICAL MALUE (ALPHA=.10) = 131.56

CHI - SQUAFE( 112 DF) = 115.01

	- 98 -	
42 0.5368 0.5487	44.	44.25
63 0.5487 0.5575	56.	- 44.25
64 0.5575 C.5664	43.	44.25
65 0.5664 0.5752	38.	44.25
66 0.5752 C.5841	47.	44.25
67 0.5841 0.5929	45.	44.25
68 0.5929 0.6018	36.	44.25
69 0.6018 0.6106	53.	44.25
70 0.6106 0.6195	54.	44.25
71 0.6195 0.6283	30. 56	44.25
72 0.6283 0.6212	30.	44.25
73 0.4440 0 6E49	41.	44.25
76 0 65400 0.6637	39	44.25
76 0.4637 0.6726	39.	44.25
77 0.6726 0.6814	52.	44.25
78 0.6814 0.6903	48.	44.25
79 0.6903 0.6091	55.	44.25
0307.0 1003.0 03	• <b>•</b> •	44.25
E1 0.70E0 C.716E	44.	44.25
82 0.7168 0.7257	35 •	44.25
83 0.7257 0.7345	51.	44.20
84 0.7245 0.7434	52.	44.25
85 0.7494 U. (p22	F3.	44.25
86 U. 7522 V. FCII	52	44.25
PE 0.7699 0.7788	32.	44.25
ES 0.7788 C.7876	37.	44.25
90 0.7876 0.7965	48.	44.25
91 0.7965 0.8053	4.4.	44.25
92 0.8053 0.8142	38.	44.25
93 0.8142 0.8230	27.	44.25
94 0.8230 0.8319	31.	44.02
95 0.8319 6.8407	<i>∶∠</i> •	44.25
96 0.8407 0.8406	40.	44.25
97 0.8446 0.8704	40.	44.25
<b>60</b> 0 2673 0 5761	51.	44.25
100 0.8761 0.8850	44.	44.25
101 6.8850 6.8938	42•	44.25
102 0.8438 0.0026	40.	44-25
103 0.0026 0.0115	43.	44.25
104 0.9115 0.9263	49.	44.25
105 0.9203 0.9292	41.	44.25
106 0.0292 0.0380	4 i • •	44+20
107 0.9380 0.9464	44 • 70	44.25
	40. 50.	44.25
110 0 0444 0 0714	41	44.25
111 0 07%4 0.952%	49.	44.25
112 0.9823 0.9911	43.	44.25
113 0.9911 1.0000	26.	44.25
ICTAL	5000.	

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	DESERVED	THEOPETICAL
MEAN	0.4969	.5000
2ND MOMENT	0.2296	•3333
3RD MOMENT	0.2461	•2500
VARIANCE	0.0827	.0833

Z - SCORE (XEAR-MU) = -C.77

#### RUNS AERVEZDELOW MEAN (.5) - 100 -

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RUN LENGTH	CBSERVED	THEORETICAL
0	1249.	1253.500
1	639.	626.750
2	321.	313.375
3	144.	156.688
4	69.	78.344
5	42.	39.172
6	24.	19.586
7	7.	9.793
8	7.	4.896
9+	4.	4.896
TOTAL	2507.	

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CHI - SQUARE( 9 DF) = 5.82

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CRITICAL	VALUE	(ALPHA=.05)	Ξ	16.92
CRITICAL	VALUE	(ALPHA=.10)	Ξ	14.68

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LAG	AC
1	900.0
2	-0.004
3	-0.002
4	0.015
5	-0.002
6	-0.011
(	0.004
ъ С	0.016
10	0.012
10	-0.028
12	-0.030
13	-0.011
14	0.004
15	0.006
16	0.015
17	-0.003
18	-0.012
19	0.006
20	0.008
21	-0.015
22	0.013
23	0.000
24	0.005
25	-0.022
20	-0.025
28	
20	
30	0.012
31	0.021
32	-0.004
33	-0.023
34	-0.016
35	-0.023
36	-0.010
37	0.008
38	-0.014
39	-0.002
40	-0.022
41	0.020
42	0.013
43	-0.016
45	-0.012
46	0.012
47	-0.016
48	0.014
49	-0.005
50	0.004

95% LIMITS ON AUTOCORDELATIONS= (+/-) 0.028 NO. AC OBSERVED OUTSIDE LIMITS= 4

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KOLMORCPOV - SMIPNOV TEST - 102 -

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11ER	ND.	ZP	<u>Z M</u>	PRCE(ZP)	PROP (7M)
•	1	0.1632	-1.0038	0.0	0.7341

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